

# SGM41516/SGM41516D High Input Voltage, 3.78A Single-Cell Battery Charger with NVDC Power Path Management

# FEATURES

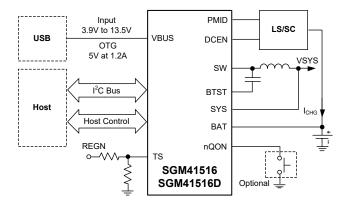
- High Efficiency, 1.5MHz, Synchronous Buck Charger
  - 95.5% Charge Efficiency at 1A from 5V Input
  - 92.5% Charge Efficiency at 2A from 9V Input
  - Optimized for 9V/12V Input
  - Selectable PFM Mode for Light Load Efficiency
- USB On-The-Go (OTG) Support (Boost Mode)
  - Boost Converter with up to 1.2A Output
  - Boost Efficiency of 93.5% at 0.5A and 92.2% at 1A
  - Accurate Hiccup Mode Over-Current Protection
  - Soft-Start Capable with up to 500µF Capacitive Load
  - Output Short Circuit Protection
  - Selectable PFM Mode for Light Load Operations
- Single Input for USB or High Voltage Adaptors
  - 3.9V to 13.5V Operating Input Voltage Range
  - 22V Absolute Maximum Input Voltage Rating
  - Programmable Input Current Limit and Dynamic Power Management (IINDPM, 100mA to 3.1A with 100mA Resolution & 3.8A) to Support USB 2.0 and USB 3.0 Standards and High Voltage Adaptors
  - Maximum Power Tracking by Programmable Input
     Voltage Limit (VINDPM) with Selectable Offset
  - VINDPM Tracking of Battery Voltage
  - Auto Detect USB BC1.2, SDP, CDP, DCP and Non-Standard Adaptors
- High Battery Discharge Efficiency with  $11m\Omega$  Switch
- Narrow Voltage DC (NVDC) Power Path Management
  - Instant-On with No or Highly Depleted Battery
  - Ideal Diode Operation in Battery Supplement Mode
- Ship Mode, Wake-Up and Full System Reset Capability by Battery FET Control

- Flexible Autonomous and I<sup>2</sup>C Operation Modes for Optimal System Performance
- Fully Integrated Switches, Current Sense and Compensation
- External Direct Charging Path Enable Output
- 9µA Ship Mode Low Battery Leakage Current
- High Accuracy
- ±0.5% Charge Voltage Regulation (8mV/Step)
- ±5% Charge Current Regulation at 1.5A
- + ±10% Input Current Regulation at 0.9A
- Safety
  - Battery Temperature Sensing (Charge/Boost Modes)
  - Thermal Regulation and Thermal Shutdown
  - Input Under-Voltage Lockout (UVLO)
  - Input Over-Voltage (ACOV) Protection

### **APPLICATIONS**

Smart Phones, EPOS Portable Internet Devices and Accessory

### SIMPLIFIED SCHEMATIC





### **GENERAL DESCRIPTION**

The SGM41516/SGM41516D are battery chargers and system power path management devices with integrated converter and power switches for using with single-cell Li-lon or Li-polymer batteries. This highly integrated 3.78A device is capable of fast charging and supports a wide input voltage range suitable for smart phones, tablets and portable systems. I<sup>2</sup>C programming makes it a very flexible powering and charger design solution.

The devices include four main power switches: input reverse blocking FET (RBFET, Q1), high-side switching FET for Buck or Boost mode (HSFET, Q2), low-side switching FET for Buck or Boost mode switching (LSFET, Q3) and battery FET that controls the interconnection of the system and battery (BATFET, Q4). The bootstrap diode for the high-side gate driving is also integrated. The internal power path has a very low impedance that reduces the charging time and maximizes the battery discharge efficiency. Moreover, the input voltage and current regulations provide maximum charging power delivery to the battery with various types of input sources.

A wide range of input sources are supported, including standard USB hosts, charging ports and USB compliant high voltage adaptors. The default input current limit is automatically selected based on the built-in USB interface. This limit is determined by the detection circuit in the system (e.g. USB PHY). SGM41516 is USB 2.0 and USB 3.0 power specifications compliant with input current and voltage regulation. It also meets USB On-The-Go (OTG) power rating specification and is capable to boost the battery voltage to supply 5.15V on VBUS with 1.2A (or 0.5A) current limit.

The system voltage is regulated slightly above the battery voltage by the power path management circuit and is kept above the programmable minimum system voltage (3.5V by default). Therefore, system power is maintained even if the battery is completely depleted or removed. Dynamic power management (DPM) feature is also included that automatically reduces the charge current if the input current or voltage limit is reached. If the system load continues to increase after reduction of charge current down to zero, the

power path management provides the deficit from battery by discharging battery to the system until the system power demand is fulfilled. This is called supplement mode, which prevents the input source from overloading.

Starting and termination of a charging cycle can be accomplished without software control. The sensed battery voltage is used to decide for starting phase of charging in one of the three phases of charging cycle: pre-conditioning, constant current or constant voltage. When the charge current falls below a preset limit and the battery voltage is above recharge threshold, the charger function will automatically terminate and end the charging cycle. If the voltage of a charged battery falls below the recharge threshold, the charger begins another charging cycle.

Several safety features are provided in the SGM41516/ SGM41516D such as over-voltage and over-current protections, battery temperature monitoring, charging safety timing, thermal shutdown and input UVLO. TS pin is connected to an NTC thermistor for battery temperature monitoring and protection in both charge and Boost modes according to JEITA profile. This device also features thermal regulation in which the charge current is reduced, if the junction temperature exceeds 80°C or 120°C (selectable).

Charging status is reported by the STAT output and fault/status bits. A negative pulse is sent to the nINT output pin as soon as a fault occurs to notify the host. BATFET reset control is provided by nQON pin to exit ship mode or for a full system reset.

The devices supply a DCEN signal to control an external P-MOSFET or load switch as a direct charging path for low voltage PMID, or to control a 2:1 switching capacitor divider for high voltage PMID.

The SGM41516/SGM41516D are available in a Green WLCSP-2.0×2.4-30B package.

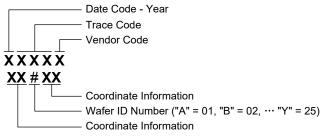


### **PACKAGE/ORDERING INFORMATION**

MODE	Ľ	PACKAGE DESCRIPTION	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKING OPTION
SGM41	516	WLCSP-2.0×2.4-30B	-40°C to +85°C	SGM41516YG/TR	SGM 41516 XXXXX XX#XX	Tape and Reel, 3000
SGM415	16D	WLCSP-2.0×2.4-30B	-40°C to +85°C	SGM41516DYG/TR	SGM 41516D XXXXX XX#XX	Tape and Reel, 3000

### MARKING INFORMATION

NOTE: XXXXX = Date Code, Trace Code and Vendor Code.



Green (RoHS & HSF): SG Micro Corp defines "Green" to mean Pb-Free (RoHS compatible) and free of halogen substances. If you have additional comments or questions, please contact your SGMICRO representative directly.



### High Input Voltage, 3.78A Single-Cell Battery Charger with NVDC Power Path Management

### **ABSOLUTE MAXIMUM RATINGS**

Voltage Range (with Respect to GND)	
VAC, VBUS (Converter Not Switching)2V to 22V (1)	
BTST, PMID (Converter Not Switching)0.3V to 22V	
SW2V to 16V	
SW (Peak for 10ns Duration)	
BTST to SW0.3V to 6V	
D+, D0.3V to 6V	
REGN, TS, nCE, BAT, BATSNS, SYS (Converter No	t
Switching)0.3V to 6V	
SDA, SCL, nINT, nQON, STAT, DCEN0.3V to 6V	
Output Sink Current	
STAT6mA	
nINT6mA	
Package Thermal Resistance	
WLCSP-2.0×2.4-30B, θ <sub>JA</sub> 63°C/W	
Junction Temperature+150°C	
Storage Temperature Range65°C to +150°C	
Lead Temperature (Soldering, 10s)+260°C	
ESD Susceptibility	
HBM	
CDM	

NOTE: 1. Maximum 28V for 10 seconds.

### **RECOMMENDED OPERATING CONDITIONS**

Input Voltage Range, V <sub>VBUS</sub>	3.9V to 13.5V
Input Current (VBUS), I <sub>IN</sub>	3.8A (MAX)
Output DC Current (SW), I <sub>SWOP</sub>	5A (MAX)
Battery Voltage, V <sub>BATOP</sub>	4.624V (MAX)
Fast Charging Current, ICHGOP	3.78A (MAX)
Discharging Current (Continuous), IBATOP	6A (MAX)
Ambient Temperature Range	40°C to +85°C
Junction Temperature Range	40°C to +125°C

### **OVERSTRESS CAUTION**

Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect reliability. Functional operation of the device at any conditions beyond those indicated in the Recommended Operating Conditions section is not implied.

### **ESD SENSITIVITY CAUTION**

This integrated circuit can be damaged if ESD protections are not considered carefully. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because even small parametric changes could cause the device not to meet the published specifications.

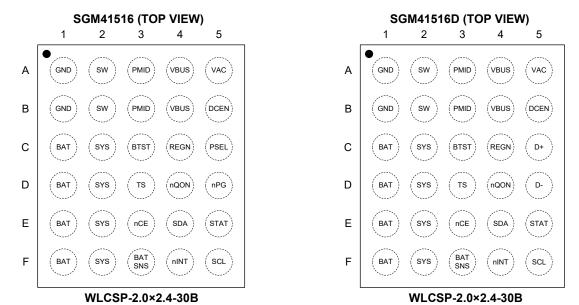
### DISCLAIMER

SG Micro Corp reserves the right to make any change in circuit design, or specifications without prior notice.



### SGM41516 SGM41516D

### **PIN CONFIGURATIONS**



### **PIN DESCRIPTION**

P	IN					
SGM 41516	SGM 41516D	NAME	TYPE <sup>(1)</sup>	FUNCTION		
A1, B1	A1, B1	GND	—	Ground Pin of the Device.		
C1, D1 E1, F1	C1, D1 E1, F1	BAT	Ρ	Battery Positive Terminal Pin. Use a $10\mu$ F capacitor between BAT and GND pins close to the device. SYS and BAT pins are internally connected by BATFET with current sensing capability.		
A2, B2	A2, B2	SW	Р	Switching Node Output. Connect SW pin to the output inductor. Connect a 47nF bootstrap capacitor from SW pin to BTST pin.		
C2, D2 E2, F2	C2, D2 E2, F2	SYS	Ρ	Connection Point to Converter Output. SYS is connected to the converter LC filter output that powers the system. BAT to SYS internal current (power from battery to system) is sensed. Connect a $20\mu$ F capacitor between SYS pin and GND close to the device (in addition to C <sub>OUT</sub> ).		
A3, B3	A3, B3	PMID	DO	PMID Pin. PMID is the actual higher voltage port of converter (Buck or Boost) and is connected to the drain of the reverse blocking MOSFET (RBFET) and the drain of HSFET. Connect a $22\mu$ F ceramic capacitor from PMID pin to GND. It is the proper point for decoupling of high frequency switching currents.		
C3	C3	BTST	Р	High-side Driver Positive Supply. It is internally connected to the bootstrap diode cathode. Use a 47nF ceramic capacitor from SW pin to BTST pin.		
D3	D3	TS	AI	Temperature Sense Input Pin. Connect to the battery NTC thermistor that is grounded on the other side. To program operating temperature window, it can be biased by a resistor divider between REGN and GND. Charge suspends if TS voltage goes out of the programmed range. It is recommended to use a 103AT-2 type thermistor. If NTC or TS pin function is not needed, use a 10k $\Omega$ /10k $\Omega$ pair for the resistor divider.		
E3	E3	nCE	DIO	Charge Enable Input Pin (Active Low). Battery charging is enabled when CHG_CONFIG bit is 1 and nCE pin is pulled low.		
F3	F3	BATSNS	AIO	Battery Voltage Sensing Pin for Charge Current Regulation. BATSNS pin is connected the actual battery pack as close as possible to reduce the parasitic trace resistance du charging.		

# **PIN DESCRIPTION (continued)**

PIN				
SGM 41516	SGM 41516D	NAME	TYPE <sup>(1)</sup>	FUNCTION
A4, B4	A4, B4	VBUS	Р	Charger Input (V <sub>IN</sub> ). The internal N-channel reverse blocking MOSFET (RBFET) is connected between VBUS and PMID pins. Place a 1 $\mu$ F ceramic capacitor from VBUS pin to GND close to the device.
C4	C4	REGN	Р	LDO Output that Powers LSFET Driver and Internal Circuits. Internally, the REGN pin is connected to the anode of the bootstrap diode. Place a $4.7\mu$ F (10V rating) ceramic capacitor between REGN pin and GND. It is recommended to place the capacitor close to the REGN pin.
D4	D4	nQON	DI	BATFET On/Off Control Pin. Use an internal pull-up to a small voltage for maintaining the default high logic (whenever a source or battery is available). In the ship mode, the BATFET is off. To exit ship mode and turn BATFET on, a logic low pulse with a duration of $t_{\text{SHIPMODE}}$ (1s TYP) can be applied to nQON. When VBUS source is not connected, a logic low pulse with a duration of $t_{\text{QON_RST}}$ (10s TYP) resets the system power (SYS) by turning BATFET off for $t_{\text{BATFET_RST}}$ (320ms TYP) and then backs on to provide a full power reset for system.
E4	E4	SDA	DIO	$I^2C$ Data Signal. Use a $10k\Omega$ pull-up to the logic high rail.
F4	F4	nINT	DO	Open-Drain Interrupt Output Pin. Use a $10k\Omega$ pull-up to the logic high rail. The nINT pin is active low and sends a negative 256µs pulse to inform host about a new charger status update or a fault.
A5	A5	VAC	AI	Sense Input for DC Input Voltage (Typically from an AC/DC Adaptor). Must be connected to VBUS pin.
B5	B5	DCEN	—	External Direct Charge Enable Pin. This pin can be set high by DCEN to enable an external direct charging device.
C5	_	PSEL	DI	Power Source Selection Input. If PSEL is pulled high, the input current limit is set to 500mA (USB 2.0) and if it is pulled low, the limit is set to 2.4A (adaptor). When the $I^2C$ link to the host is established, the host can program a different input current limit value by writing to the IINDPM[4:0] register. (SGM41516 only)
_	C5	D+	AIO	Positive USB Data Line. D+/D- based USB device protocol detection and voltage of this pin can be set by DP_VSET[1:0]. (SGM41516D only)
D5	_	nPG	DO	Open-Drain Active Low Input Power Good Indicator. Use a $10k\Omega$ pull-up to the logic high rail. A low state indicates a good input (UVLO < V <sub>VBUS</sub> < ACOV, and above sleep mode threshold, I <sub>LIM</sub> > 30mA). (SGM41516 only)
_	D5	D-	AIO	Negative USB Data Line. D+/D- based USB device protocol detection and voltage of this pin can be set by DM_VSET[1:0]. (SGM41516D only)
E5	E5	STAT	DO	Open-Drain Charge Status Output. Use a $10k\Omega$ pull-up to the logic high rail (or an LED + a resistor). The STAT pin acts as follows: During charge: low (LED ON). Charge completed or charger in sleep mode: high (LED OFF). Charge suspended (in response to a fault): 1Hz, 50% duty cycle pulses (LED BLINKS). The function can be disabled via EN_ICHG_MON[1:0] register.
F5	F5	SCL	DI	$I^2C$ Clock Signal. Use a $10k\Omega$ pull-up to the logic high rail.

### NOTE:

1. AI = Analog Input, AO = Analog Output, AIO = Analog Input and Output, DI = Digital Input, DO = Digital Output, DIO = Digital Input and Output, P = Power.



# **ELECTRICAL CHARACTERISTICS**

PARAM	ETER	SYMBOL	SYMBOL CONDITIONS		MIN	TYP	MAX	UNITS
Quiescent Currer	nts							
Battery Discharge (BAT, SW, SYS) ir		I <sub>BQ_VBUS</sub>	$V_{BAT}$ = 4.5V, $V_{VBUS}$ < $V_{VAC_UVLOZ}$ , leakage between BAT and VBUS, BATFET off			0.1	1	μA
Battery Discharge (BAT) in Buck Mod		I <sub>BQ_HIZ_BOFF</sub>	$V_{BAT} = 4.5V, HIZ mode a or no VBUS, I2C disable$			9	20	μA
Battery Discharge (BAT, SW, SYS)	Current	I <sub>BQ_HIZ_BON</sub>	V <sub>BAT</sub> = 4.5V, HIZ mode a or no VBUS, I <sup>2</sup> C disable			15	30	μA
			V <sub>VBUS</sub> = 5V, HIZ mode a no battery	nd BATFET_DIS = 1,		25	40	
Input Supply Curre		Ivbus_hiz	V <sub>VBUS</sub> = 12V, HIZ mode no battery	and BATFET_DIS = 1,		55	80	μA
(VBUS) in Buck M	ode		V <sub>VBUS</sub> = 12V, V <sub>VBUS</sub> > V <sub>B</sub>	AT, converter not switching		2.5	3.5	
		I <sub>VBUS</sub>	$V_{BAT}$ = 3.8V, $I_{SYS}$ = 0A, V converter switching, BA	$V_{VBUS} > V_{BAT}, V_{VBUS} > V_{VAC_UVLOZ},$ TFET off		4		mA
Battery Discharge in Boost Mode	Current	I <sub>BOOST</sub>	$V_{BAT}$ = 4.2V, $I_{VBUS}$ = 0A,	converter switching		3		mA
BAT Pin, VAC Pir	n and VBUS Pir	Power-Up	1			1	1	
VBUS Operating F	0	$V_{\text{VBUS}_{OP}}$	V <sub>VBUS</sub> rising		3.9		13.5	V
VBUS UVLO to Have Active I <sup>2</sup> C (with No Battery) Seen by Sense VAC Pin		V <sub>VAC_UVLOZ</sub>	$V_{VAC}$ rising, $T_J$ = +25°C			3.2	3.4	V
I <sup>2</sup> C Active Hystere	sis	V <sub>VAC_UVLOZ_HYS</sub>	V <sub>VAC</sub> falling from above	V <sub>VAC_UVLOZ</sub>		400		mV
V <sub>VAC</sub> Minimum (as Conditions) to Tur		V <sub>VAC_PRESENT</sub>	$V_{VAC}$ rising, $T_J$ = +25°C			3.4	3.7	V
V <sub>VAC</sub> Hysteresis (a Conditions) to Tur	s One of the	V <sub>VAC_PRESENT_HYS</sub>	$V_{\text{VAC}}$ falling from above $V_{\text{VAC}\_\text{PRESENT}}$			400		mV
Sleep Mode Fallin	g Threshold	V <sub>SLEEP</sub>	$V_{VAC}$ - $V_{BAT}$ , $V_{VBUSMIN_FALL} \le V_{BAT} \le V_{REG}$ , $V_{VAC}$ falling		20	50	80	mV
Sleep Mode Rising	g Threshold	V <sub>SLEEPZ</sub>	$V_{VAC}$ - $V_{BAT}$ , $V_{VBUSMIN_FALL} \le V_{BAT} \le V_{REG}$ , $V_{VAC}$ rising		150	190	230	mV
VAC	6.5V Setting			OVP[1:0] = 01	6.3	6.5	6.7	
Over-Voltage	10.5V Setting	$V_{\text{VAC}\_\text{OV}\_\text{RISE}}$	V <sub>VAC</sub> rising	OVP[1:0] = 10	10.2	10.5	10.8	V
Rising Threshold	14V Setting			OVP[1:0] = 11	13.7	14	14.3	
VAC	6.5V Setting			OVP[1:0] = 01		110		
Over-Voltage	10.5V Setting	V <sub>VAC_OV_HYS</sub>		OVP[1:0] = 10		260		mV
Hysteresis	14V Setting			OVP[1:0] = 11		300		
BAT Voltage to Have Active I <sup>2</sup> C (No Source on VBUS)		V <sub>BAT_UVLOZ</sub>	V <sub>BAT</sub> rising	·	2.65			V
BAT Depletion Threshold		$V_{\text{BAT}\_\text{DPL}\_\text{FALL}}$	$V_{\text{BAT}}$ falling		2	2.25	2.5	v
BAT Depletion Threshold		$V_{\text{BAT}\_\text{DPL}\_\text{RISE}}$	V <sub>BAT</sub> rising		2.25	2.5	2.75	v
BAT Depletion Rising Hysteresis		$V_{BAT\_DPL\_HYS}$				250		mV
Bad Adaptor Deter (Internal Current S	ink)	I <sub>BAD_SRC</sub>	Sink current from VBUS	to GND		30		mA
Bad Adaptor Deter Voltage Drop) Fall	ing Threshold	$V_{VBUSMIN\_FALL}$	$V_{VBUS}$ falling		3.7	3.8	3.9	V
Bad Adaptor Deter Voltage Drop) Hys		$V_{\text{VBUSMIN}_\text{HYS}}$				230		mV



PARAMETER	SYMBOL	CON	DITIONS	MIN	TYP	MAX	UNITS
Power Path Management							
System Regulation Voltage	V <sub>SYS</sub>	I <sub>SYS</sub> = 0A, V <sub>BAT</sub> = 4.4\ BATFET_DIS = 1	$/, V_{BAT} > V_{SYS_{MIN}},$		V <sub>BAT</sub> + 50mV		V
Minimum DC System Voltage Output	V <sub>SYS_MIN</sub>	I <sub>SYS</sub> = 0A, V <sub>BAT</sub> < SYS BATFET_DIS = 1	6_MIN[2:0] = 101 (3.5V),	3.6	3.65		V
Maximum DC System Voltage Output	V <sub>SYS_MAX</sub>	$I_{SYS} = 0A, V_{BAT} \le 4.4 \setminus BATFET_DIS = 1$	$V, V_{BAT} > V_{SYS_{MIN}} = 3.5V,$	4.4	4.45	4.5	V
Top Reverse Blocking MOSFET On-Resistance between VBUS and PMID - Q1	R <sub>on_rbfet</sub>				18		mΩ
Top Switching MOSFET On-Resistance between PMID and SW - Q2	R <sub>on_hsfet</sub>	V <sub>REGN</sub> = 5V			21		mΩ
Bottom Switching MOSFET On-Resistance between SW and GND - Q3	R <sub>on_lsfet</sub>	V <sub>REGN</sub> = 5V			23		mΩ
BATFET Forward Voltage in Supplement Mode	V <sub>FWD</sub>				25		mV
Battery Charger	I	1		1	I	L	I
Charge Voltage Program Range	VBAT_REG_RANGE			3.856		4.624	V
Charge Voltage Step	V <sub>BAT_REG_STEP</sub>				32		mV
		VREG[4:0] = 01011	T <sub>J</sub> = +25°C	4.192	4.208	4.224	- V
		(4.208V)	T <sub>J</sub> = -40°C to +85°C	4.184		4.232	
		VREG[4:0] = 01111 (4.352V) VREG[4:0] = 10001 (4.400V)	T <sub>J</sub> = +25°C	4.338	4.352	4.366	
Charge Voltage Setting	V <sub>BAT_REG</sub>		$T_J = -40^{\circ}C$ to $+85^{\circ}C$	4.326		4.375	
			T <sub>J</sub> = +25°C	4.385	4.400	4.415	
			$T_J = -40^{\circ}C$ to $+85^{\circ}C$	4.374		4.423	
		$V_{BAT_{REG}} = 4.208V$ or	T <sub>J</sub> = +25°C	-0.4		0.4	0/
Charge Voltage Setting Accuracy	V <sub>BAT_REG_ACC</sub>	$V_{BAT_{REG}} = 4.352V \text{ or}$ $V_{BAT_{REG}} = 4.400V$	$T_J = -40^{\circ}C$ to $+85^{\circ}C$	-0.6		0.6	%
Charge Current Regulation Range	I <sub>CHG_REG_RANGE</sub>			0		3780	mA
Charge Current Regulation Step	I <sub>CHG_REG_STEP</sub>				60		mA
			I <sub>CHG</sub> = 60mA	0.045	0.06	0.08	
			I <sub>CHG</sub> = 240mA	0.215	0.24	0.275	
		V <sub>BAT</sub> =3.1V, T,I = +25℃	I <sub>CHG</sub> = 720mA	0.67	0.72	0.77	
		1, 200	I <sub>CHG</sub> = 1.38A	1.31	1.38	1.45	
Charge Current Degulation Setting			I <sub>CHG</sub> = 2.04A	1.97	2.04	2.11	^
Charge Current Regulation Setting	I <sub>CHG_REG</sub>		I <sub>CHG</sub> = 60mA	0.035	0.06	0.085	A
		$\lambda = 2.0 \lambda$	I <sub>CHG</sub> = 240mA	0.22	0.255	0.285	-
		V <sub>BAT</sub> = 3.8V, T <sub>J</sub> = +25°C	I <sub>CHG</sub> = 720mA	0.695	0.76	0.82	
		· *	I <sub>CHG</sub> = 1.38A	1.3	1.4	1.515	
		I <sub>CHG</sub> = 2.04A		1.92	2.04	2.16	
Pre-Charge Current Regulation Setting	I <sub>PRECHG</sub>	IPRECHG[3:0] = 001	0 (180mA), T <sub>J</sub> = +25°C	160	185	210	mA
Battery LOW Falling Threshold	V <sub>BATLOW_FALL</sub>	I <sub>CHG</sub> = 480mA		2.83	2.95	3.07	V
Battery LOW Rising Threshold	V <sub>BATLOW_RISE</sub>	Change from pre-cha	arge to fast charging	3.07	3.15	3.23	V



PARAMETER	SYMBOL	CO	NDITIONS	MIN	TYP	MAX	UNITS
Termination Current Regulation	1	$I_{CHG} > 1.26A,$ $V_{BAT_{REG}} = 4.208V,$ $T_{J} = +25^{\circ}C$	ITERM[3:0] = 0010 (180mA)	160	190	220	mA
Setting	Iterm	$\begin{split} I_{CHG} &\leq 1.26\text{A}, \\ V_{BAT\_REG} &= 4.208\text{V}, \\ T_J &= +25^{\circ}\text{C} \end{split}$	ITERM[3:0] = 0010 (180mA)	165	190	215	IIIA
Battery Short Voltage	V <sub>SHORT</sub>	V <sub>BAT</sub> falling		1.95	2	2.05	V
Dattery Short Voltage	V <sub>SHORTZ</sub>	V <sub>BAT</sub> rising		2.15	2.2	2.25	v
Battery Short Current	I <sub>SHORT</sub>	$V_{BAT} < V_{SHORTZ}$			90		mA
Recharge Threshold below	M	$V_{BAT}$ falling, VRECHG = 0	0 (100mV)	90	110	135	m)/
V <sub>BAT_REG</sub>	V <sub>RECHG</sub>	V <sub>BAT</sub> falling, VRECHG =	1 (200mV)	200	220	245	mV
System Discharge Load Current	I <sub>SYS_LOAD</sub>	V <sub>SYS</sub> = 4.2V			20		mA
BATFET MOSFET On-Resistance	R <sub>ON_BATFET</sub>	$V_{BAT}$ = 4.2V, measured fr	om BAT pin to SYS pin		11	17	mΩ
Input Voltage and Current Regul	ation (DPM: Dy	namic Power Managem	ent)				
			VINDPM_OS = 00 (4.4V)	4.32	4.4	4.48	V
Innut Voltage Degulation Limit	VINDPM		VINDPM_OS = 01 (6.4V)	6.3	6.4	6.5	V
Input Voltage Regulation Limit		VINDPM[3:0] = 0101	VINDPM_OS = 10 (8V)	7.88	8	8.1	V
			VINDPM_OS = 11 (11V)	10.8	11	11.15	V
Input Voltage Regulation Accuracy	VINDPM_ACC			-2		2	%
Input Voltage Regulation Limit Tracking VBAT	$V_{\text{DPM}_{\text{VBAT}}}$	V <sub>BAT</sub> = 4V, V <sub>INDPM</sub> = 3.9V, VDPM_BAT_TRACK[1:0		4.22	4.33	4.44	V
Input Voltage Regulation Accuracy Tracking VBAT	V <sub>DPM_VBAT_ACC</sub>	T <sub>J</sub> = +25°C		-2.5		2.5	%
			IINDPM[4:0] = 00100 (500mA)	425		630	mA
USB Input Current Regulation		$V_{VBUS} = 5V$ ,	IINDPM[4:0] = 01000 (900mA)	820		1000	
Limit	INDPM	current pulled from SW, $T_J = +25^{\circ}C$	IINDPM[4:0] = 01110 (1.5A)	1365		1540	
			IINDPM[4:0] = 10011 (2A)	1780		2040	
Input Current Limit during System Start-Up Sequence	I <sub>IN_START</sub>				270		mA
BAT Pin Over-Voltage Protection	า						
Battery Over-Voltage Threshold	$V_{\text{BATOVP}_{\text{RISE}}}$	As percentage of	V <sub>BAT</sub> rising	102.8	103.8	104.8	%
Dattery Over-voltage Threshold	$V_{\text{BATOVP}_{\text{FALL}}}$	$V_{BAT_{REG}}, T_{J} = +25^{\circ}C$	V <sub>BAT</sub> falling	100.8	101.8	102.8	70
Thermal Regulation and Therma							
Junction Temperature Regulation	<b>-</b>		TREG = 1 (120°C)		120		*0
Threshold	T <sub>JUNCTION_REG</sub>	Temperature increasing	TREG = 0 (80°C)		80		°C
Thermal Shutdown Rising Temperature	T <sub>SHUT</sub>	Temperature increasing			150		°C
Thermal Shutdown Hysteresis	T <sub>SHUT_HYS</sub>				30		°C



PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
JEITA Thermistor Comparator (Bu	ck Mode)						
T1 (0°C) Threshold Voltage on TS Pin	V <sub>T1</sub>	Charge suspends if temperature T is below T1 (T < T1), as percentage of $V_{REGN}$		72.7	73.2	73.7	%
V <sub>T1</sub> Falling		As percentage of V <sub>REGN</sub>		71.1	71.6	72.1	
T2 (10°C) Threshold Voltage on TS Pin	V <sub>T2</sub>	Charge sets to $I_{CHG}/2$ and the lower of 4.1V and $V_{REG}$ if T1 < T < T2, as percentage of $V_{REGN}$		67.5	68	68.5	%
V <sub>T2</sub> Falling		As percentage of V <sub>REGN</sub>		66.2	66.7	67.2	
V <sub>T3</sub> Rising		As percentage of V <sub>REGN</sub>		45.4	45.9	46.4	
T3 (45°C) Threshold Voltage on TS Pin	V <sub>T3</sub>	Charge sets to the lower of 4.1V a if T3 < T < T4, as percentage of V		44	44.5	45	%
V <sub>T4</sub> Rising		As percentage of V <sub>REGN</sub>		35	35.5	36	
T4 (60°C) Threshold Voltage on TS Pin	$V_{T4}$	Charge suspends if T > T4, as pe V <sub>REGN</sub>	rcentage of	33.7	34.2	34.7	%
Cold or Hot Thermistor Comparate	or (Boost Mode	)					
Cold Temperature Threshold (TS Pin Voltage Rising Threshold)	V <sub>BCOLD</sub>	As percentage of V <sub>REGN</sub> (approx	-20°C w/ 103AT)	79.5	80	80.5	%
TS Voltage Falling (Exit from Cold Range to Cool)		As percentage of V <sub>REGN</sub>		78.5	79	79.5	
Hot Temperature Threshold (TS Pin Voltage Falling Threshold) TS Voltage Rising	V <sub>BHOT</sub>	As percentage of V <sub>REGN</sub> (approx. 6	60°C w/ 103AT)	30.7	31.2	31.7	%
(Exit Hot Range to Warm)		As percentage of V <sub>REGN</sub>		34	34.5	35	
Charge Over-Current Comparator	(Cycle-by-Cycl	e)			1	1	1
HSFET Cycle-by-Cycle Over-Current Threshold	I <sub>HSFET_OCP</sub>	T <sub>J</sub> = +25°C		7.1		10.3	А
System Overload Threshold	I <sub>BATFET_OCP</sub>	T <sub>J</sub> = +25°C		8			A
Charge Under-Current Comparato	r (Cycle-by-Cyc	cle)					
LSFET Under-Current Falling Threshold	I <sub>LSFET_UCP</sub>	Change rectifier from synchronou non-synchronous mode	s mode to		180		mA
PWM							
PWM Switching Frequency	f <sub>sw</sub>	Buck mode		1380	1500	1620	kHz
F WW Switching Frequency	ISW	Oscillator frequency, $T_J = +25^{\circ}C$	Boost mode	1380	1500	1620	NI IZ
Maximum PWM Duty Cycle <sup>(1)</sup>	D <sub>MAX</sub>				99		%
Boost Mode Operation							
Boost Mode Regulation Voltage	$V_{\text{OTG}\_\text{REG}}$	V <sub>BAT</sub> = 3.8V, I <sub>PMID</sub> = 0A, BOOSTV[	[1:0] = 10 (5.15V)	5.05	5.15	5.25	V
Boost Mode Regulation Voltage Accuracy	$V_{\text{OTG}\_\text{REG}\_\text{ACC}}$	V <sub>BAT</sub> = 3.8V, I <sub>PMID</sub> = 0A, BOOSTV	[1:0] = 10 (5.15V)	-2		2	%
		V <sub>BAT</sub> falling, MIN_BAT_SEL = 0		2.9	3	3.1	
Exit Boost Mode due to Low Battery	Variantianta	V <sub>BAT</sub> rising, MIN_BAT_SEL = 0		3.1	3.2	3.3	v
Voltage	V <sub>BATLOW_OTG</sub>	V <sub>BAT</sub> falling, MIN_BAT_SEL = 1		2.37	2.5	2.63	
		V <sub>BAT</sub> rising, MIN_BAT_SEL = 1		2.55	2.7	2.87	
OTG Mode Maximum Output Current	I <sub>OTG</sub>	BOOST_LIM = 1 (1.2A), T <sub>J</sub> = +25°C		1.05	1.25	1.5	А
OTG Over-Voltage Threshold	$V_{\text{OTG}_{OVP}}$	Rising threshold		5.85	6	6.15	V
HSFET Under-Current Falling Threshold	I <sub>OTG_HSZCP</sub>	Change rectifier from synchronou non-synchronous mode	s mode to		350		mA



 $(V_{VAC\_UVLOZ} < V_{VAC} < V_{VAC\_OV}$  and  $V_{VAC} > V_{BAT} + V_{SLEEP}$ ,  $T_J = -40^{\circ}$ C to +85°C, typical values are at  $T_J = +25^{\circ}$ C, unless otherwise noted.)

PARAMETER		SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
REGN LDO								
	ltago	V <sub>REGN</sub>	V <sub>VBUS</sub> = 9V, I <sub>REGN</sub> = 40mA	4.5	4.8	5.2	V	
REGN LDO Output Voltage		V REGN	V <sub>VBUS</sub> = 5V, I <sub>REGN</sub> = 20mA	4.8	4.9	5	v	
Logic I/O Pin Charac	Logic I/O Pin Characteristics (nCE, PSEL, DCEN, SCL, SDA and nINT)							
Input Low Threshold	nCE, PSEL, SCL, SDA,	V <sub>IL</sub>				0.4	V	
Input High Threshold	nINT	V <sub>IH</sub>		1.3			V	
Input Low Threshold	DCEN	VIL			0.1		V	
Input High Threshold	DOLIN	V <sub>IH</sub>			REGN		V	
High-Level Leakage Current		I <sub>BIAS</sub>	Pull up rail 1.8V		0.1	1	μA	
Logic I/O Pin Characteristics (nPG, STAT) – Open-Drain								
Low-Level Output Voltage		V <sub>OL</sub>				0.2	V	

NOTE:

1. Guaranteed by design. Not production tested.



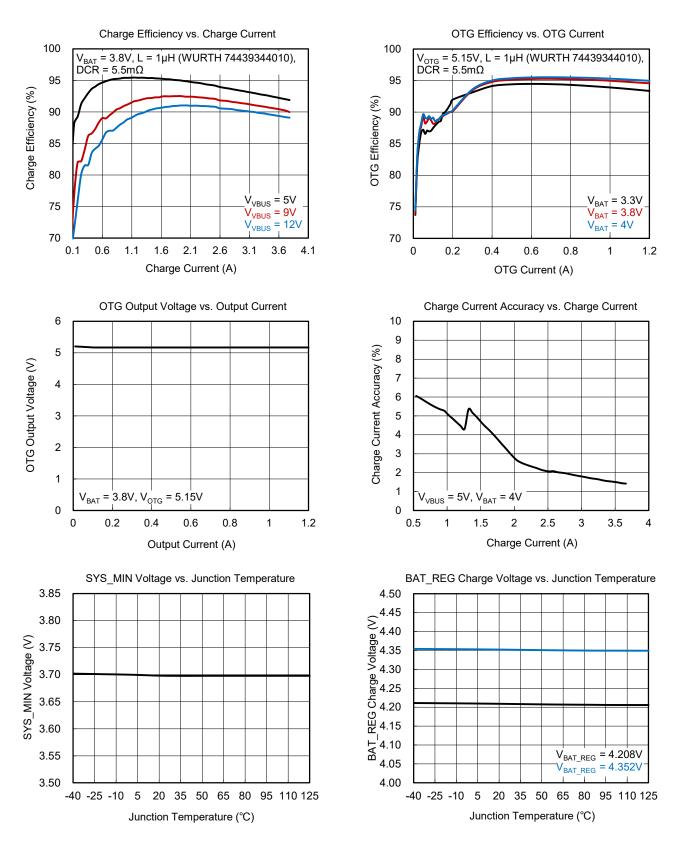
### TIMING REQUIREMENTS

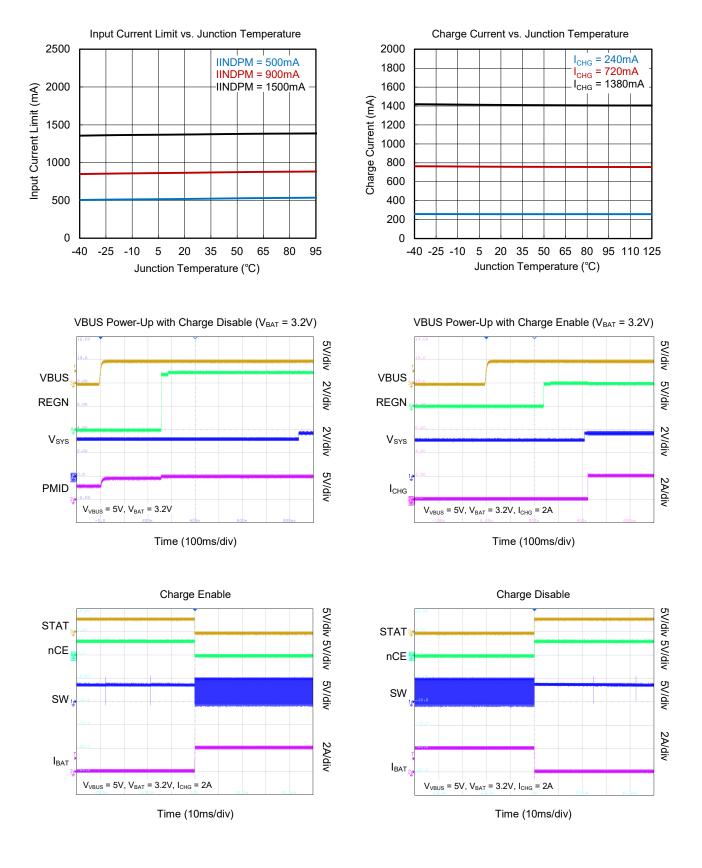
 $(V_{VAC_UVLOZ} < V_{VAC} < V_{VAC_OV} \text{ and } V_{VAC} > V_{BAT} + V_{SLEEP}, T_J = +25^{\circ}C, \text{ unless otherwise noted.})$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>VBUS</sub> /V <sub>BAT</sub> Power-Up		·				•
VBUS OVP Reaction Time	t <sub>ACOV</sub>	$V_{\text{VBUS}}$ rising above ACOV threshold to turn off Q2		0.1		μs
Wait Window for Bad Adaptor Detection	t <sub>BAD_SRC</sub>			30		ms
Battery Charger						
Deglitch Time for Charge Termination	$t_{\text{TERM}_{DGL}}$			230		ms
Deglitch Time for Recharge	t <sub>RECHG_DGL</sub>			230		ms
System Over-Current Deglitch Time to Turn off Q4	t <sub>SYSOVLD_DGL</sub>			112		μs
Pattery Over Veltage Deglitch Time to Dischle Cherge	t <sub>BATOVP</sub>			1		μs
Battery Over-Voltage Deglitch Time to Disable Charge	t <sub>BATOVP_DCEN</sub>	DCEN active	2.8	3.5	4.4	ms
Typical Charge Safety Timer Range	t <sub>SAFETY</sub>	CHG_TIMER = 1	14.5	16	17.9	h
Typical Top-Off Timer Range	t <sub>TOP_OFF</sub>	TOPOFF_TIMER[1:0] = 10 (35min)	31	35	39	min
nQON Timing and Ship Mode Timing						•
nQON Negative Pulse Low Pulse Width to Turn on BATFET and Exit Ship Mode	t <sub>shipmode</sub>		0.9	1	1.2	s
nQON Low Time to Reset BATFET	$t_{QON_RST}$		9	10	11.5	s
BATFET off Time during Full System Reset	t <sub>BATFET_RST</sub>		285	320	355	ms
Wait Delay for Entering Ship Mode	t <sub>SM_DLY</sub>		11	12.3	13.5	s
Digital Clock and Watchdog Timer						
Watchdog Reset Time	t <sub>wDT</sub>	WATCHDOG[1:0] = 01, REGN LDO disabled		40.9		s
Digital Clock Frequency in Low Power	f <sub>LPDIG</sub>	REGN LDO disabled		31		kHz
Digital Clock Frequency	f <sub>DIG</sub>	REGN LDO enabled		500		kHz
I <sup>2</sup> C Interface	-	·			•	•
SCL Clock Frequency	f <sub>SCL</sub>			400		kHz



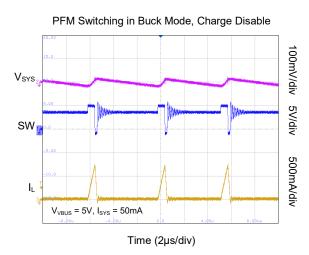
# **TYPICAL PERFORMANCE CHARACTERISTICS**



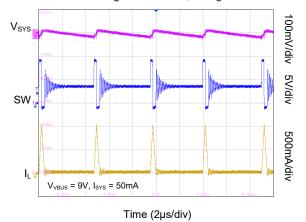


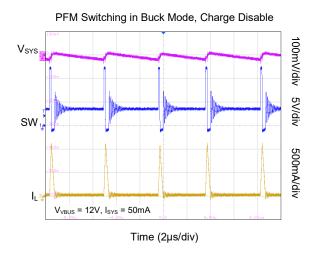
SGM41516

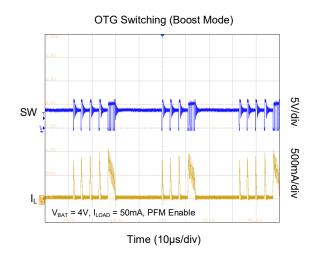
SGM41516D

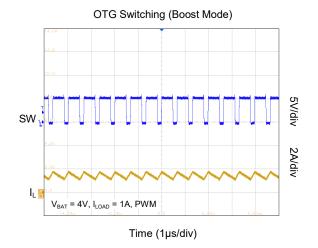


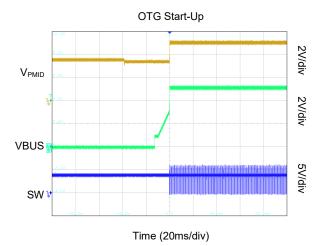
PFM Switching in Buck Mode, Charge Disable



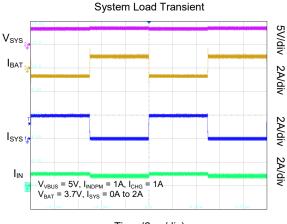




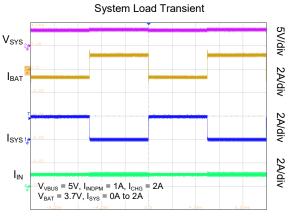




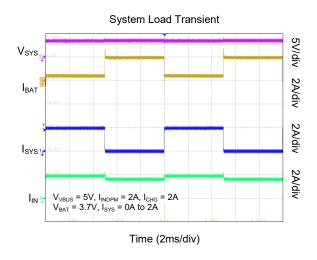
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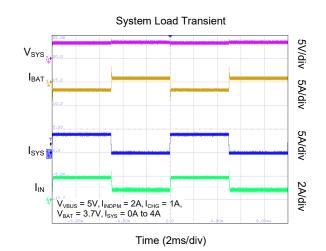


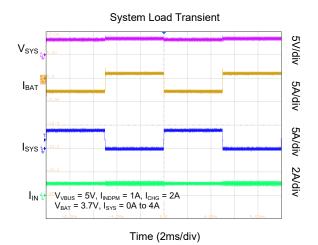
Time (2ms/div)

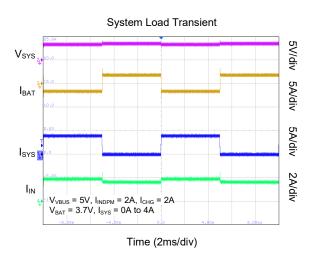




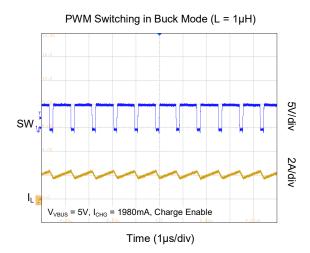


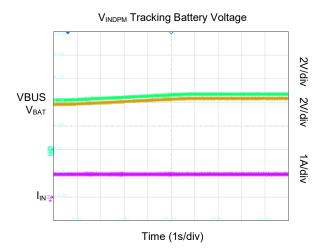


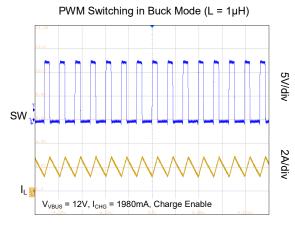




SG Micro Corp







Time (1µs/div)



# TYPICAL APPLICATION CIRCUIT

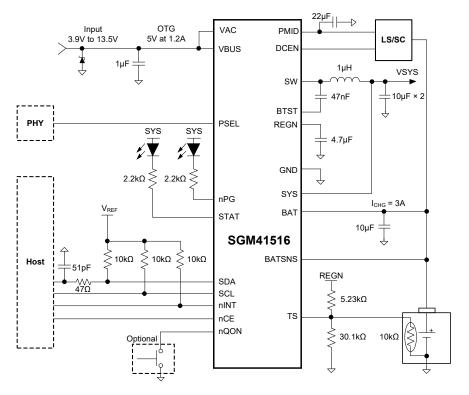
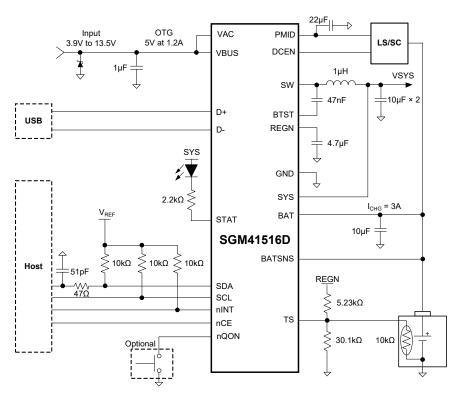


Figure 1. SGM41516 Typical Application Circuit







FUNCTIONAL BLOCK DIAGRAM

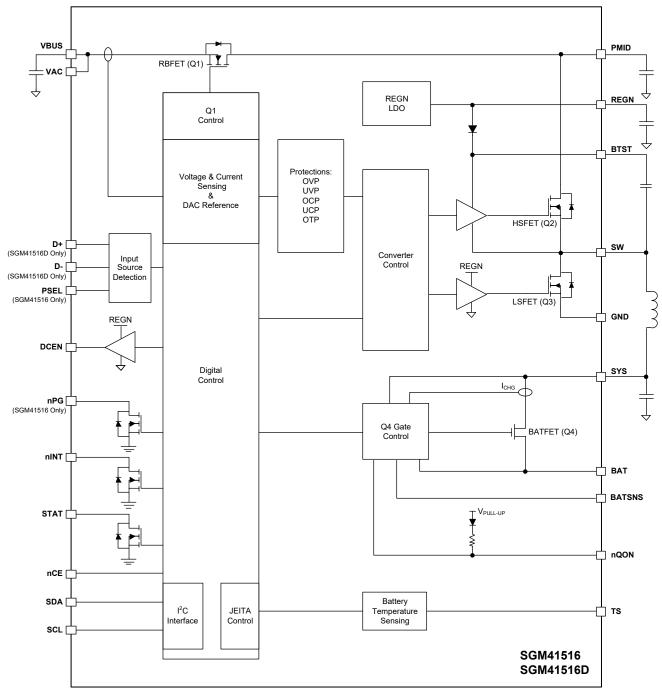


Figure 3. Block Diagram



### **DETAILED DESCRIPTION**

The SGM41516/SGM41516D are power management and charger devices for applications such as cell phones and tablets that use high capacity single-cell Li-lon or Li-polymer batteries. The SGM41516/SGM41516D can accommodate a wide range of input sources including USB, wall adaptor and car chargers. It is optimized for 5V input (USB voltage) but is capable to operate with input voltages from 3.9V to 13.5V. It also supports JEITA profile for battery charging safety at high or low temperatures. Automatic power path selection to power the system (SYS) from the input source (VBUS), battery (BAT) or both is another feature of the device. Battery charge current is programmable and can reach to a maximum of 3.78A (charge). In the Boost mode, the battery voltage is boosted to power the VBUS pin (1.2A MAX) when it is a power receiving node (USB OTG) that is typically regulated to 5.15V.

The device may operate in several different modes:

In HIZ mode, the reverse blocking FET (Q1), internal REGN LDO, converter switches and some other parts of the internal circuit remain off to save the battery while it supplies DC power to the system through BATFET.

In the sleep mode, the switching is stopped. The charger goes to the sleep mode when the input source voltage (V<sub>VAC</sub>) is not high enough for charging the battery. In other words, V<sub>VAC</sub> is smaller than V<sub>BAT</sub> + V<sub>SLEEP</sub> (where V<sub>SLEEP</sub> is a small threshold) and Buck converter is not able to charge, even at its maximum duty cycle. The Boost may also go to the sleep mode if similar issue happens in the reverse direction (when V<sub>VAC</sub> is almost equal to or smaller than V<sub>BAT</sub>).

In supplement mode, the input source power is not enough to supply system demanded power and the battery assists by discharging to the system in parallel, and providing the deficit.

### Power-On Reset (POR)

The internal circuit of the device is powered from the greater voltage between V<sub>VBUS</sub> and V<sub>BAT</sub>. When the voltage of the selected source goes above its UVLO level (V<sub>VBUS</sub> > V<sub>VAC\_UVLOZ</sub> or V<sub>BAT</sub> > V<sub>BAT\_UVLOZ</sub>), a POR happens and activates the sleep comparator, battery depletion comparator and BATFET driver. Upon activation, the I<sup>2</sup>C interface will also be ready for communication and all registers reset to their default values.

# Power-Up from Battery Only (No Input Source)

When only the battery is presented as a source and its voltage is above depletion threshold ( $V_{BAT_DPL_RISE}$ ), the BATFET turns on and connects the battery to the system. The quiescent current is minimum because the REGN LDO remains off. Conduction losses are also low due to small R<sub>DSON</sub> of BATFET. Low losses help to extend the battery run time.

The discharge current through BATFET is continuously monitored. In the supplement mode, if a system overload (or short) occurs ( $I_{BAT} > I_{BATFET_OCP}$ ), the BATFET is turned off immediately and BATFET\_DIS bit is set to 1. The BATFET will not enable until the input source is applied or one of the BATFET Enable Mode (Exit Ship Mode) methods (explained later) is used to activate the BATFET.

# Power-Up Process from the Input Power Source

Upon connection of an input source (VBUS), its voltage sensed from VAC pin is checked to turn on the internal REGN LDO regulator and the bias circuits (no matter whether the battery is present or not). The input current limit is determined and set before the Buck converter is started. The sequences of actions when VBUS as input source is powered up are:

- 1. REGN LDO power-up.
- 2. Poor power source detection (qualification).

**3. Input power source type detection.** (Based on D+/D- or PSEL input. It is used to set the default input current limit (IINDPM[4:0]).)

4. Setting of the input voltage limit threshold (VINDPM threshold).

5. DC/DC converter power-up.

Details of the power-up steps are explained in the following sections.



### **REGN LDO Power-Up**

The REGN low dropout regulator powers the internal bias circuits, HSFET and LSFET gate drivers and TS rail (thermistor pin). The STAT pin can also be pulled up to REGN. The REGN enables when the following 2 conditions are satisfied and remain valid for a 220ms delay time, otherwise the device stays in high impedance mode (HIZ) with REGN LDO off.

1. V<sub>VAC</sub> > V<sub>VAC\_PRESENT</sub>.

2.  $V_{VAC} > V_{BAT} + V_{SLEEPZ}$  (in Buck mode) or  $V_{VBUS} < V_{BAT} + V_{SLEEP}$  (in Boost mode).

In HIZ state, the quiescent current drawn from VBUS is very small (less than  $I_{\text{VBUS}\_\text{HIZ}}$ ). System is only powered by the battery in HIZ mode.

**Poor Power Source Detection (Qualification)** 

When REGN LDO is powered, the input source (adaptor) is checked for its type and current capacity. To start the Buck converter, the input (VBUS) must meet the following conditions:

1.  $V_{VBUS} < V_{VAC_OV}$ .

2.  $V_{VBUS} > V_{VBUS\_MIN}$  during  $t_{BAD\_SRC}$  test period (30ms TYP) in which the  $I_{BAD\_SRC}$  (30mA TYP) current is pulled from VBUS.

If the test is failed, the conditions are repeatedly checked every 2 seconds. As soon as the input source passes qualification, the VBUS\_GD bit in status register is set to 1 and a pulse is sent to the nINT pin to inform the host. Type detection will start as next step.

#### **Input Power Source Type Detection**

The input source detection will run through the D+/D- lines or the PSEL pin while REGN LDO is powered and after the VBUS\_GD bit is set. The SGM41516D can detect the input source types which include SDP/DCP and non-standard adaptor through the D+/D- pins following USB BC1.2 Specification. The SGM41516 sets the input current limit via PSEL pin. A pulse is sent to nINT pin to inform the host when the input source type detection is completed. Some registers and pins are also updated as detailed below:

1. Input current limit register (the value in the IINDPM[4:0]) is changed to set current limit.

2. PG\_STAT (power good) bit is set.

3. VBUS\_STAT[2:0] register is updated to indicate USB or adaptor input source types.

The input current is always limited by the IINDPM[4:0] register and the limit can be updated by the host if needed.

#### Input Current Limit by PSEL (SGM41516)

PSEL pin interfaces with USB physical layer (PHY) for input current limit setting. The USB PHY device output is used to detect if the input is a USB host or a charging port. In the host-control mode, the host must enable IINDET\_EN bit for reading the PSEL value and updating the IINDPM[4:0]. In the default mode, IINDPM[4:0] is updated automatically by PSEL value in real time as given in Table 1.

#### Table 1. Input Current Limit Setting from PSEL

Input Detection	PSEL Pin	Input Current Limit (I <sub>∟ıм</sub> )	VBUS_STAT[2:0]
USB Host SDP	High	500mA	001
Adaptor Low		2400mA	010

### Input Current Limit by D+/D- Detection (SGM41516D)

The SGM41516D integrates a D+/D- based input source detection to set the input current limit when VBUS is plugged in. When the input source is plugged in, the SGM41516D starts USB BC1.2 detection and set the SDP/DCP related input current limit. And if the data contact detection timer expires, the non-standard adaptor detection starts and then sets the input current limit. Please refer to Table 2 and Table 3.

#### **Table 2. Non-Standard Adaptor Detection**

Non-Standard Adaptor	D+ Threshold	D- Threshold	Input Current Limit (A)
Divider 1	VD+ within V2P7	VD- within V2P0	2.1
Divider 2	VD+ within V1P2	VD- within V1P2	2
Divider 3	VD+ within V2P0	VD- within V2P7	1
Divider 4	VD+ within V2P7	VD- within V2P7	2.4



 Table 3. Input Current Limit Setting from D+/D- Detection

D+/D- Detection	Input Current Limit (I <sub>INLIM</sub> )	
USB SDP (USB500)	500mA	
USB DCP	2.4A	
Divider 1	2.1A	
Divider 2	2A	
Divider 3	1A	
Divider 4	2.4A	
Unknown 5V Adaptor	500mA	

### Force Detection of Input Current Limit

The host can set IINDET\_EN bit to 1 in host mode to force the device to run. And the IINDET\_EN bit returns to 0 by itself and input result is updated after the detection is completed.

### D+/D- Output Voltage Setting (SGM41516D)

The host can be set D+/D- output voltages by DP\_VSET[1:0] and DM\_VSET[1:0] to HIZ, 0V, 0.6V or 3.3V. When BC1.2 detection runs, these bits are ignored.

# Setting of the Input Voltage Limit Threshold (VINDPM Threshold)

A wide voltage range (3.9V to 5.4V, 5.9V to 9V, 10.5V to 12V) is supported for the input voltage limit setting in VINDPM[3:0] and VINDPM\_OS[1:0]. 4.5V is the default for USB.

The device supports dynamic tracking of the battery voltage (VINDPM). VDPM\_BAT\_TRACK[1:0] bits can be used to enable tracking (00 to disable tracking) and set the tracking offset value. When the tracking is enabled, the input voltage limit will be set to the larger value between the VINDPM[3:0] and  $V_{BAT}$  + VDPM\_BAT\_TRACK[1:0]. The VDPM\_BAT\_TRACK[1:0] tracking offset can be set to 200mV, 250mV or 300mV. And this function only takes effect when VINDPM\_OS[1:0] = 00.

### **DC/DC Converter Power-Up**

The 1.5MHz switching converter composed of LSFET and HSFET is enabled, which can start switching when the input current limit is set. Converter is initiated with a soft-start when the system voltage is ramped up. If SYS voltage is less than 2.2V, the input current is limited to 200mA or IINDPM[4:0], whichever is smaller, otherwise the limit is set to IINDPM[4:0].

The BATFET remains on to charge the battery if the battery charging function is enabled, otherwise BATFET turns off.

When converter operates for battery charging, it acts as an efficient, fixed frequency synchronous Buck converter regardless of the input/output voltages and currents. However, it is capable to switch to PFM mode at light load when charging is disabled or when the detected battery voltage is less than minimum system voltage setting. PFM operation can be enabled or prevented in either Buck or Boost mode using the PFM\_DIS bit.

### **Boost Mode**

The SGM41516/SGM41516D support USB On-The-Go. When a load device is connected to the USB port, the converter can operate as a step-up synchronous converter (Boost mode) with 1.5MHz switching frequency to supply power from the battery to that load. The 500mA USB OTG output current limit requirement is achieved by programming, however, the Boost converter can deliver 1.2A to the output (default limit). Converter will be set to Boost mode if at least 30ms is passed from enabling this mode (OTG\_CONFIG bit = 1) and the following conditions are satisfied:

- 1.  $V_{BAT} > V_{BATLOW_OTG}$ .
- 2.  $V_{VBUS} < V_{BAT} + V_{SLEEP}$  (in sleep mode).
- 3. Acceptable voltage range at TS pin ( $V_{BHOT} < V_{TS} < V_{BCOLD}$ ).

The output voltage is set to  $V_{VBUS} = 5.15V$  and is maintained as long as  $V_{BAT}$  is above  $V_{BATLOW_OTG}$ . The output current can reach up to the programmed value by BOOST\_LIM bit (0.5A or 1.2A). The VBUS\_STAT[2:0] status register bits are set to 111 in Boost mode (OTG).

To minimize the output overshoot in Boost mode, the device starts with PFM first and then switches to PWM. As stated before, PFM can be avoided by using PFM\_DIS bit in Buck and Boost modes.



# Host Mode and Default Mode Operation with Watchdog Timer

After a power-on reset, the device starts in default mode (standalone) with all registers reset as if the watchdog timer is expired. When the host is in sleep mode or there is no host, the device stays in the default mode in which the SGM41516/SGM41516D operate like an autonomous charger. The battery is charged for 16 hours (default value for the fast charging safety timer). Then the charge stops while Buck converter continues to operate to power the system load. In this mode, WATCHDOG\_FAULT bit is high.

Most of the flexibility features of the SGM41516/SGM41516D become available in the host mode when the device is controlled by a host with  $I^2C$ . By setting the WD\_RST bit to 1, the charger mode changes from default mode to host mode.

In this mode the WATCHDOG\_FAULT bit is low and all device parameters can be programmed by the host. To prevent device watchdog from reset that results in going back to default mode, the host must disable the watchdog timer by setting WATCHDOG[1:0] = 00, or it must consistently reset the watchdog timer before expiry by writing 1 to WD\_RST to prevent WATCHDOG\_FAULT bit from being set. Every time a 1 is written to the WD\_RST, the watchdog timer will restart counting. Therefore, it should be reset again before overflow (expiry) to keep the device in the host mode. If the watchdog timer expires (WATCHDOG\_FAULT bit = 1), the device returns to default mode and all registers are reset to their default values except for IINDPM[4:0], VINDPM[3:0], VINDPM\_OS[1:0], BATFET\_DLY and BATFET\_DIS bits that keep their values unchanged.

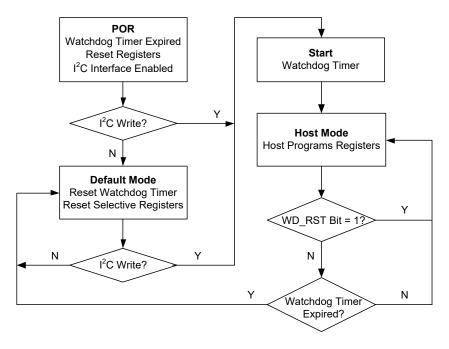


Figure 4. Watchdog Timer Flow Chart



### **Battery Charging Management**

The SGM41516/SGM41516D are designed for charging single-cell Li-lon or Li-poly batteries with a charge current up to 3.78A (MAX). The battery connection switch (BATFET) is in the charge or discharge current path and features low on-resistance ( $10m\Omega$ ) to allow high efficiency and low voltage drop.

**Charging Cycle in Autonomous Mode** 

Charging is enabled if CHG\_CONFIG = 1 and nCE pin is pulled low. In default mode, the SGM41516/SGM41516D run a charge cycle with the default parameters itemized in Table 4. At any moment, the device can be controlled by charging to the host mode.

### Table 4. Charging Parameter Default Setting

Default Mode	SGM41516/SGM41516D	
Charging Voltage (V <sub>REG</sub> )	4.208V	
Charging Current (I <sub>CHG</sub> )	2.04A	
Pre-Charge Current (I <sub>PRECHG</sub> )	180mA	
Termination Current (I <sub>TERM</sub> )	180mA	
Temperature Profile	JEITA	
Safety Timer	16h	

#### Start a New Charging Cycle

If the converter can start switching and all the following conditions are satisfied a new charge cycle starts:

- NTC temperature fault is not asserted (TS pin).
- Safety timer fault is not asserted.
- BATFET is not forced off. (BATFET\_DIS bit = 0).

• Charging enabled (3 conditions: CHG\_CONFIG bit = 1, ICHG[5:0] register is not 0mA and nCE pin is low).

 $\bullet$  Battery voltage is below the programmed full charge level (V\_{\mathsf{REG}}).

A new charge cycle starts automatically if battery voltage falls below the recharge threshold level ( $V_{REG}$  - 100mV or  $V_{REG}$  - 200mV configured by VRECHG bit). Also, if the charge cycle is completed, a new charging cycle can be initiated by toggling of the nCE pin or CHG\_CONFIG bit.

Normally a charge cycle terminates when the charge voltage is above the recharge threshold level and the charging current falls below the termination threshold if the device is not in thermal regulation or Dynamic Power Management (DPM) mode.

### **Charge Status Report**

STAT is an open-drain output pin that reports the status of charge and can drive an LED for indication: a low indicates that charging is in progress, a high shows that charging is completed or disabled and alternating low/high (blinking) show a charging fault. The STAT may be disabled (keep the open-drain switch off) by setting EN\_ICHG\_MON[1:0] = 11.

The CHRG\_STAT[1:0] status register reports the present charging phase and status by two bits: 00 = charging disabled, 01 = in pre-charge, 10 = in fast charging (constant current mode or constant voltage mode) and 11 = charging completed.

A negative pulse is sent on nINT pin to inform the host when a charging cycle is completed.

In addition, the output status of STAT pin can be set by STAT\_SET[1:0] bits, 00 = LED off (HIZ), 01 = LED on (low), 10 = LED blinking at 1s on 1s off, 11 = LED blinking at 1s on 3s off. This two bits only take effect when EN\_ICHG\_MON[1:0] = 01.

### **Battery Charging Profile**

The SGM41516/SGM41516D feature a full battery charging profile with five phases. In the beginning of the cycle, the battery voltage ( $V_{BAT}$ ) is tested, and appropriate current and voltage regulation levels are selected as shown in Table 5. Depending on the detected status of the battery, the proper phase is selected to start or for continuation of the charging cycle. The phases are trickle charge ( $V_{BAT}$  < 2.2V), pre-charge, fast-charge (constant current and constant voltage) and top-off trickle charge.

Table 5. Cl	narging Curre	nt Setting Ba	sed on V <sub>BAT</sub>
-------------	---------------	---------------	-------------------------

V <sub>BAT</sub> Voltage	Selected Charging Current	Default Value in the Register	CHRG_STAT[1:0]
< 2.2V	I <sub>SHORT</sub>	90mA	01
2.2V to 3.15V	I <sub>PRECHG</sub>	180mA	01
> 3.15V	I <sub>CHG</sub>	2.04A	10

Note that in the DPM or thermal regulation modes, normal charging functions are temporarily modified: The charge current will be less than the value in the register. The termination is disabled, and the charging safety timer is slowed down by counting at half clock rate.

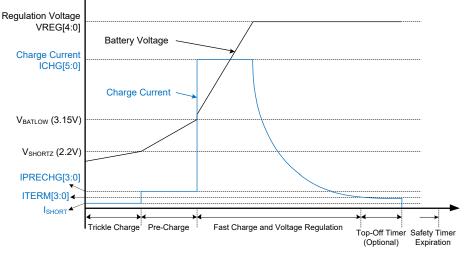


Figure 5. Battery Charging Profile

### Charge Termination

A charge cycle is terminated when the battery voltage is higher than the recharge threshold and the charge current falls below the programmed termination current. Unless there is a high power demand for system and it needs to operate in supplement mode, the BATFET turns off at the end of the charge cycle. Even after termination, the Buck converter operates continuously to supply the system.

CHRG\_STAT[1:0] is set to 11 and a negative pulse is sent to nINT pint after termination.

If the charger is regulating input current, input voltage or junction temperature instead of charge current, termination will be temporarily prevented. EN\_TERM bit is termination control bit and can be set to 0 to disable termination before it happens.

At low termination currents (60mA TYP), the offset in the internal comparator may give rise to a higher (+10mA to +20mA) actual termination current. A delay in termination can be added (optional) as a compensation for comparator offset using a programmable top-off timer. During the delay, constant voltage charge phase continues and gives the falling charge current a chance to drop closer to the programmed value. The top-off delay timer has the same restrictions of the safety timer. As an example, under some conditions, if the

safety timer is suspended, the top-off timer will also be suspended or if the safety timer is slowed down, the termination timer will also be slowed down. The TOPOFF\_ACTIVE bit reports the active/not active status of the top-off timer. The CHRG\_STAT[1:0] and TOPOFF\_ACTIVE bits can be read to find status of the termination.

Any of the following events resets the top-off timer:

- 1. Disable to enable transition of nCE (charge enable).
- 2. A low to high change in the status of termination.
- 3. Set REG\_RST bit to 1.

The setting of the top-off timer is applied at the time of termination detection and unless a new charge cycle is started, modifying the top-off timer parameters after termination has no effect. A negative pulse is sent to nINT when top-off timer is started or ended.

#### Temperature Qualification

The charging current and voltage of the battery must be limited when battery is cold or hot. A thermistor input for battery temperature monitoring is included in the device that can protect the battery based on JEITA guidelines.



# SGM41516High Input Voltage, 3.78A Single-Cell Battery ChargerSGM41516Dwith NVDC Power Path Management

### **DETAILED DESCRIPTION (continued)**

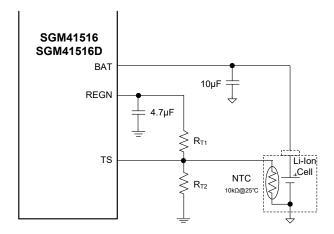
### **Compliance with JEITA Guideline**

JEITA guideline (April 20, 2007 release) is implemented in the device for safe charging of the Li-Ion battery. JEITA highlights the considerations and limits that should be considered for charging at cold or hot battery temperatures. High charge current and voltage must be avoided outside normal operating temperatures (typically 0 °C and 60 °C). This functionality can be disabled if not needed. Four temperature levels are defined by JEITA from T1 (minimum) to T4 (maximum). Outside this range, charging should be stopped. The corresponding voltages sensed by NTC are named V<sub>T1</sub> to V<sub>T4</sub>. Due to the sensor negative resistance, a higher temperature results in a lower voltage on TS pin. The battery cool range is between T1 and T2 and the warm range is between T3 and T4. Charge must be limited in the cool and warm ranges.

One of the conditions for starting a charge cycle is having the TS voltage within  $V_{T1}$  to  $V_{T4}$  window limits. If during the charge, battery gets too cold or too hot and TS voltage exceeds the T1 - T4 limits, charging is suspended (zero charge current) and the controller waits for the battery temperature to come back within the T1 to T4 window.

JEITA recommends reducing charge current to 1/2 of fast charging current or lower at cool temperatures (T1 - T2). For warmer temperature (within T3 - T4 range), charge voltage is recommended to be kept below 4.1V.

The SGM41516/SGM41516D exceed the JEITA requirement by their flexible charge parameter settings. At warm temperature range (T3 - T4), the charge voltage is set to the lower of  $V_{REG}$  and 4.1V when JEITA VSET H = 0, the charge voltage is set to  $V_{REG}$  when JEITA VSET H = 1, and the charge current can be reduced down to 0%, 20% or 50% of fast charging current by the JEITA ISET H[1:0] bits. At cool temperatures (T1 - T2), the current setting can be reduced down to 50% or 20% of fast charging current selectable by the JEITA ISET L bit when JEITA ISET L EN = 1, and the charge voltage is set to  $V_{REG}$  when JEITA VSET L = 0, the charge voltage is set to the lower of V<sub>REG</sub> and 4.1V when JEITA VSET L = 1. Additional, the cool threshold T2 and warm threshold T3 can be changed through JEITA VT2[1:0] and JEITA\_VT3[1:0], and the charge current can be disabled by setting JEITA ISET L EN = 0.



### Figure 6. Battery Thermistor Connection and Bias Network

A 103AT-2 type thermistor is recommended to use for the SGM41516/SGM41516D. Other thermistors may be used and bias network (see Figure 6) can be calculated based on the following equations:

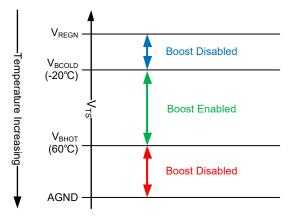
$$R_{T2} = \frac{R_{THCOLD} \times R_{THHOT} \times \left(\frac{1}{V_{T1}} - \frac{1}{V_{T4}}\right)}{R_{THHOT} \times \left(\frac{1}{V_{T4}} - 1\right) - R_{THCOLD} \times \left(\frac{1}{V_{T1}} - 1\right)}$$
(1)  
$$R_{T1} = \frac{\left(\frac{1}{V_{T1}} - 1\right)}{\left(\frac{1}{R_{T2}}\right) + \left(\frac{1}{R_{THCOLD}}\right)}$$
(2)

where  $V_{T1}$  and  $V_{T4}$  are  $T_{COLD}$  and  $T_{HOT}$  threshold voltages on TS pin as percentage to  $V_{REGN}$ ,  $R_{THCOLD}$  and  $R_{THHOT}$  are thermistor resistances ( $R_{TH}$ ) at desired T1 (Cold) and T4 (Hot) temperatures. Select  $T_{COLD}$  = 0°C and  $T_{HOT}$  = 60°C for Li-Ion or Li-polymer batteries. For a 103AT-2 type thermistor  $R_{THCOLD}$  = 27.28k $\Omega$  and  $R_{THHOT}$  = 3.02k $\Omega$ , the calculation results are:  $R_{T1}$  = 5.23k $\Omega$  and  $R_{T2}$  = 30.1k $\Omega$ .



### Boost Mode Temperature Monitoring (Battery Discharge)

The device is capable to monitor the battery temperature for safety during the Boost mode. The temperature must remain within the V<sub>BCOLD</sub> to V<sub>BHOT</sub> thresholds, otherwise the Boost mode will be suspended and VBUS\_STAT[2:0] bits are set to 000. Moreover, NTC\_FAULT[2:0] register is updated to report Boost mode cold or hot condition. Once the temperature returns within the window, the Boost mode is resumed and NTC\_FAULT[2:0] register is cleared to 000 (normal).



### Figure 7. TS Pin Thermistor Temperature Window Settings in Boost Mode

#### Safety Timer

Abnormal battery conditions may result in prolonged charge cycles. An internal safety timer is considered to stop charging in such conditions. If the safety time is expired, CHRG\_FAULT[1:0] bits are set to 11 and a negative pulse is sent to nINT pin. By default, the charge time limit. And it is 2 hours if the battery voltage does not rise above  $V_{BATLOW}$  threshold. And it is 16 hours if it goes above  $V_{BATLOW}$ . This feature is optional and can be disabled by clearing EN\_TIMER bit. The 16 hours limit can also be reduced to 7 hours by clearing CHG TIMER bit.

The safety timer counts at half clock rate when charger is running under input voltage regulation, input current regulation, JEITA cool or thermal regulation. Because in these conditions, the actual charge current is likely to be less than the register setting. As an example, if the safety timer is set to 7 hours and the charger is regulating the input current (IINDPM\_STAT bit = 1) in the whole charging cycle, the actual safety time will be 16 hours. Clearing the TMR2X\_EN bit will disable the half clock rate feature.

The safety timer is paused if a fault occurs or charger is in supplement mode, charging is suspended. It will resume once

the fault condition is removed. If charging cycle is stopped by a restart or by toggling nCE pin or CHG\_CONFIG bit, the timer resets and restarts a new timing.

### Narrow Voltage DC (NVDC) Design in SGM41516/SGM41516D

The SGM41516/SGM41516D feature an NVDC design using the BATFET that connects the system and battery. By using the linear region of the BATFET, the charger regulates the system bus voltage (SYS pin) above the minimum setting using Buck converter even if the battery voltage is very low. MOSFET linear mode allows for the large voltage difference between SYS and BAT pins to appear as V<sub>DS</sub> across the switch while conducting and charging battery. SYS\_MIN[2:0] register sets the minimum system voltage (default 3.5V). If the system is in minimum system voltage regulation, VSYS\_STAT bit is set.

The BATFET operates in linear region when the battery voltage is below the minimum system voltage setting. The system voltage is regulated to 180mV (TYP) above the minimum system voltage setting. The battery gradually gets charged and its voltage rises above the minimum system voltage and lets BATFET to change from linear mode to fully turned-on switch such that the voltage difference between the system and battery is the small V<sub>DS</sub> of fully on BATFET.

The system voltage is always regulated to 50mV (TYP) above the battery voltage if:

1. The charging is terminated.

2. Charging is disabled and the battery voltage is above the minimum system voltage setting.

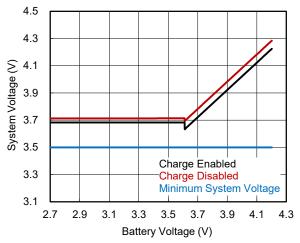


Figure 8. System Voltage vs. Battery Voltage

### SGM41516/SGM41516D Dynamic Power Management (DPM)

The SGM41516/SGM41516D have a dynamic power management (DPM) feature. To implement DPM, the device always monitors the input current and voltage to regulate power demand from the source and avoid input adaptor overloading or to meet the maximum current limits specified in the USB specs. Overloading an input source may results in either current trying to exceed the input current limit ( $I_{INDPM}$ ) or the voltage tending to fall below the input voltage limit ( $V_{INDPM}$ ). With DPM, the device keeps the VSYS regulating to its minimum setting by reducing the battery charge current adequately such that the input parameter (voltage or current) does not exceed the limit. In other words, charge current is reduces to satisfy  $I_{IN} \leq I_{INDPM}$  or  $V_{IN} \geq V_{INDPM}$  whichever occurs first. DPM can be either an  $I_{IN}$  type (IINDPM) or  $V_{IN}$  type (VINDPM) depending on which limit is reached.

Changing to the supplement mode may be required if the charge current is decreased and reached to zero, but the input is still overloaded. In this case, the charger reduces the system voltage below the battery voltage to allow operation in the supplement mode and provide a portion of system power demand from the battery through the BATFET.

The IINDPM\_STAT or VINDPM\_STAT status bits are set during an IINDPM or VINDPM respectively. Figure 9 summarizes the DPM behavior (IINDPM type) for a design example with a 9V/1.2A adaptor, 3.2V battery, 2.8A charge current setting and 3.4V minimum system voltage setting.

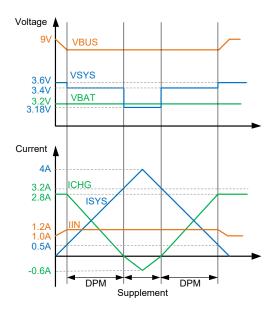


Figure 9. DPM Behavior Plot

### **Battery Supplement Mode**

If the system voltage drops below the battery voltage, the BATFET gradually starts to turn on. The threshold margin is 180mV if V<sub>SYS\_MIN</sub> setting is less than V<sub>BAT</sub>. And it is 45mV if V<sub>SYS\_MIN</sub> setting is larger than V<sub>BAT</sub>. At low discharge currents, the BATFET gate voltage is regulated (R<sub>DS</sub> modulation) such that the BATFET V<sub>DS</sub> stays at 30mV. At higher currents, the BATFET will turn fully on (reaching its lowest R<sub>DSON</sub>). From this point, increasing the discharge current will linearly increase the BATFET V<sub>DS</sub> (determined by R<sub>DSON</sub> × I<sub>D</sub>). Use of the MOSFET linear mode at lower currents prevents swinging oscillation of entering and exiting the supplement mode.

BATFET gate regulation V-I characteristics is shown in Figure 10. If the battery voltage falls below its minimum depletion, the BATFET turns off and exits supplement mode.

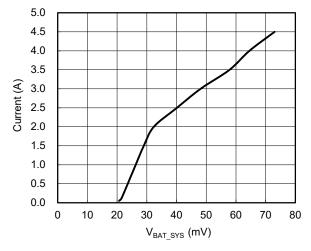


Figure 10. BATFET Gate Regulation V-I Curve

### **BATFET Control for System Power Reset** and Ship Mode

### Ship Mode (BATFET Disable)

Ship mode is usually used when the system is stored or in idle state for a long time or is in shipping. In such conditions, it is better to completely disconnect battery and make system voltage zero to minimize the leakage and extend the battery life. To enter ship mode, the BATFET has to be forced off by setting BATFET\_DIS bit. The BATFET turns off immediately if BATFET\_DLY bit is 0, or turns off after a  $t_{SM_DLY}$  delay (12.3 seconds) if BATFET\_DLY is set.



### Exit Ship Mode (BATFET Enable)

To exit the ship mode and enable the BATFET, one of the following can be applied:

With the chip no powered by VBUS:

1. Connect the adaptor to the input with a valid voltage to the VBUS input.

2. Pull nQON pin from logic high to low to enable BATFET, for example, by shorting nQON to GND. The negative pulse width should be at least a  $t_{SHIPMODE}$  (1s TYP) for deglitching.

With the chip already powered by VBUS:

- 3. Clear BATFET\_DIS bit by using host and  $I^2C$ .
- 4. Set REG\_RST to 1 to reset all registers.

5. Apply a negative pulse to nQON pin (same as 2).

### Full System Reset with BATFET Using nQON

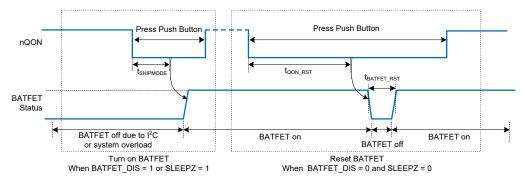
When the input source is not present, the BATFET can act as a load on/off switch between the system and battery. This feature can be used to apply a power-on reset to the system. Host can toggle BATFET\_DIS bit to cycle power off/on and reset the system. A push-button connected to nQON pin or a negative pulse can also be used to manually force a system power cycle when BATFET is ON (BATFET\_DIS bit = 0). For this function, a negative logic pulse with a minimum width of  $t_{QON\_RST}$  (10s TYP) must be applied to the nQON pin that results in a temporary BATFET turn off for  $t_{BATFET\_RST}$  (320ms TYP) that automatically turns on afterward. Setting BATFET\_RST\_EN to 0 can disable the function.

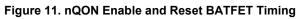
In summary, the nQON pin controls BATFET and system reset in two different ways:

1. Enable BATFET: Applying an nQON logic high to low transition with longer than  $t_{SHIPMODE}$  deglitch time (negative pulse) turns on BATFET to exit ship mode (Figure 11 left). HIZ is also enabled (EN\_HIZ = 1) when exiting shipping mode. After exiting shipping mode, the host can disable HIZ (EN\_HIZ = 0). OTG cannot be enabled (OTG\_CONFIG = 1) until HIZ is disabled.

2. Reset BATFET: By applying a logic low for a duration of at least  $t_{QON\_RST}$  to nQON pin while VBUS is not powered and BATFET is allowed to turn on (BATFET\_DIS bit = 0), the BATFET turns off for  $t_{BATFET\_RST}$  and then it is re-enabled resulting in a system power-on reset (Figure 11 right). This function can be disabled by clearing BATFET\_RST\_EN bit.

A typical push button circuit for nQON is given in Figure 12.





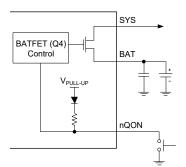


Figure 12. nQON Manual Operation Circuit



Status Outputs Pins (nPG, STAT and nINT)

**Power Good Indication (nPG Pin and PG\_STAT Bit)** When a good input source is connected to VBUS and input type is detected, the PG\_STAT status bit goes high and the nPG pin goes low. A good input source is detected if all following conditions on  $V_{VBUS}$  are satisfied and input type detection is completed:

- $V_{VBUS}$  is in the operating range:  $V_{VAC_UVLOZ} < V_{VBUS} < V_{VAC_OV}$ .
- Device is not in sleep mode:  $V_{VBUS} > V_{BAT} + V_{SLEEP}$ .

• Input source is not poor:  $V_{VBUS} > V_{VBUSMIN}$  (3.8V TYP) when  $I_{BAD\_SRC}$  (30mA TYP) loading is applied. (Poor source detection.)

• Completed input source type detection.

### Charge Status (STAT Pin)

Charging state is indicated with the open-drain STAT pin as explained in Table 6. This pin is able to drive an LED (see Figure 1 or Figure 2). The functionality of the STAT pin is disabled if the EN\_ICHG\_MON[1:0] bits are set to 11.

#### **Table 6. STAT Pin Function**

Charging State	STAT Indicator
Charging battery (or recharge)	Low (LED ON)
Charging completed	High (LED OFF)
Charging is disabled or in sleep mode	High (LED OFF)
Charge is suspended due to input over-voltage, TS fault, timer faults or system over-voltage or Boost mode is suspended (TS fault).	1Hz Blinking
EN_ICHG_MON[1:0] = 01, controlled by register only, no matter with charging state.	STAT_SET[1:0]

### nINT Interrupt Output Pin

When a new update occurs in the charger states, a  $256\mu s$  negative pulse is sent through the nINT pin to interrupt the host. The host may not continuously monitor the charger device and by receiving the interrupt, it can react and check the charger situation on time.

The following events can generate an interrupt pulse:

- 1. Faults reflected in REG0x09 register (watchdog, Boost overload, charge faults and battery over-voltage).
- 2. Charging completed.
- PSEL or D+/D- detection identified a connected source (USB or adaptor).

- 4. Input source voltage entered the "input good" range:
  - a)  $V_{VBUS}$  exceeded  $V_{BAT}$  (not in sleep mode).
  - b)  $V_{\text{VBUS}}$  came below  $V_{\text{VAC}\_\text{OV}}.$
  - c)  $V_{VBUS}$  remained above  $V_{VBUSMIN}$  (3.8V TYP) when  $I_{BAD\ SRC}$  (30mA TYP) load current is applied.
- 5. Input removed or out of the "input good" range.
- 6. A DPM event (VINDPM or IINDPM) occurred (a maskable interrupt).

Once a fault/flag happens, the INT pulse is asserted immediately and the fault/flag bits are updated in REG0x09 and REG0x0E. Fault/flag status is not reset in the register until the host reads it. A new fault/flag will not assert a new INT pulse until the host reads REG0x09 and REG0x0E and all the previous faults/flags are cleared. Therefore, in order to read the current time faults, the host must read REG0x09 two times consecutively. The first read returns the history of the fault register status (from the time of the last read or reset) and the second one checks the current active faults. As an exception, the NTC\_FAULT bit reports the actual real-time status of TS pin.

### **Current Pulse Control Protocol**

The device provides the control to generate the VBUS current pulse protocol to communicate with adjustable high voltage adaptor, in order to signal adaptor to increase/decrease output voltage. To enable the interface, the EN PUMPX bit must be set. Then the host can select the increase/decrease voltage pulse by setting either the PUMPX UP or PUMPX DN bit to start the VBUS current pulse sequence. During the current pulse sequence, the PUMPX UP and PUMPX DN bits are set to indicate pulse sequence is in progress and the device pulses the input current limit between current limit set forth by IINDPM[4:0] register and the 100mA current limit. When the pulse sequence is completed, the input current limit is returned to value set by IINDPM[4:0] register and the PUMPX UP or PUMPX DN bit is cleared. In addition, the EN PUMPX can be cleared during the current pulse sequence to terminate the sequence and force charger to return to input current limit as set forth by the IINDPM[4:0] register immediately. When EN\_PUMPX bit is low, writing to PUMPX UP and PUMPX DN bits would be ignored and have no effect on VBUS current limit.



### SGM41516/SGM41516D Protection Features

Monitoring of Voltage and Current

During the converter operation, the input and system voltages (VBUS and VSYS) and switch currents are constantly monitored to assure safe operation of the device in both Buck and Boost modes, as will be explained below.

### **Buck Mode Voltage and Current Monitoring** 1. Input Over-Voltage (ACOV)

Converter switching will stop as soon as VBUS voltage exceeds  $V_{VAC_OV}$  over-voltage limit that is programmable by OVP[1:0] in REG0x06. It is selectable among 5.5V, 6.5V (default), 10.5V and 14V for USB or 5V, 9V or 12V adaptors respectively.

Each time VBUS exceeds the OVP limit, an INT pulse is asserted. As long as the over-voltage persists, the CHRG\_FAULT[1:0] bits are set to 01 in REG0x09. Fault will be cleared to 00 if the voltage comes back below limit (and a hysteresis threshold) and host reads the fault register. Charger resumes its normal operation when the voltage comes back below OVP limit.

### 2. System Over-Voltage (SYSOVP)

During a system load transient, the device clamps the system voltage to protect the system components from over-voltage. The SYSOVP over-voltage limit threshold is  $350\text{mV} + \text{V}_{\text{BAT}}$ , or  $350\text{mV} + \text{V}_{\text{SYS}\_\text{MIN}}$  when in SYSMIN condition (programmed minimum system regulation voltage + 350mV). Once a SYSOVP occurs, switching stops to clamp any overshoot and a 30mA sink current is applied to SYS to pull the voltage down.

### Boost Mode Voltage and Current Monitoring

In Boost mode, the RBFET (reverse blocking) and LSFET (low-side switch) FET currents and VBUS voltage are monitored for protection.

### 1. Soft-Start on VBUS

Boost mode begins with a soft-start to prevent large inrush currents when it is enabled.

### 2. Output Short Protection for VBUS

Short circuit protection is provided for VBUS output in Boost mode. To accept different types of load connected to VBUS and OTG adaptation, an accurate constant current regulation control is implemented for Boost mode. In case of a short circuit on VBUS pin, the Q1 turns off and retries 7 times (Hiccup). If short is not removed after retries, the OTG will be disabled by clearing OTG\_CONFIG bit. Also, an INT pulse is sent and the BOOST\_FAULT bit is set to 1 in REG0x09. When the host activates the Boost mode again, the BOOST\_FAULT bit will be cleared.

### 3. Output Over-Voltage Protection for VBUS

In Boost mode, converter stops switching and exits Boost mode (by clearing OTG\_CONFIG bit) if VBUS voltage rises above regulation and exceeds the  $V_{OTG_OVP}$  over-voltage limit (6V TYP). An INT pulse is sent and the BOOST\_FAULT bit is set to 1.

### SGM41516/SGM41516D Thermal Regulation and Shutdown

#### **Buck Mode Thermal Protections**

Internal junction temperature (T<sub>J</sub>) is always monitored to avoid overheating. A limit of +120 °C is considered for maximum IC surface temperature in Buck mode and if T<sub>J</sub> intends to exceed this level, the device reduces the charge current to keep maximum temperature limited to +120 °C (thermal regulation mode) and sets the THERM\_STAT bit to 1. As expected, the actual charging current is usually lower than programmed value during thermal regulation. Therefore, the safety timer runs at half clock rate and charge termination is disabled during thermal regulation.

If the junction temperature exceeds  $T_{SHUT}$  (+150°C), thermal shutdown protection arise in which the converter is turned off, CHRG\_FAULT[1:0] bits are set to 10 in the fault register and an INT pulse is sent.

When the device recovers and  $T_J$  falls below the hysteresis band of  $T_{SHUT\_HYS}$  (30°C under  $T_{SHUT}$ ), the converter resumes automatically.

### **Boost Mode Thermal Protections**

Similar to Buck mode,  $T_{\rm J}$  is monitored in Boost mode for thermal shutdown protection. If junction temperature exceeds  $T_{\rm SHUT}~(+150~^{\circ}{\rm C}$ ), the Boost mode will be disabled (OTG\_CONFIG bit clears). If  $T_{\rm J}$  falls below the hysteresis band of  $T_{\rm SHUT\_HYS}~(30^{\circ}{\rm C}$  under  $T_{\rm SHUT}$ ), Boost can recover again by re-enabling OTG\_CONFIG bit by host.



### **Battery Protections**

### Battery Over-Voltage Protection (BATOVP)

The over-voltage limit for the battery is 4% above the battery regulation voltage setting. In case of a BATOVP, charging or external direct charging stops right away, the BAT\_FAULT bit is set to 1 and an INT pulse is sent.

#### **Battery Over-Discharge Protection**

If battery discharges too much and V<sub>BAT</sub> falls below the depletion level (V<sub>BAT\_DPL\_FALL</sub>), the device turns off BATFET to protect battery. This protection is latched and is not recovered until an input source is connected to the VBUS pin. In such condition, the battery will start charging with the small I<sub>SHORT</sub> current (90mA TYP) first as long as V<sub>BAT</sub> < V<sub>SHORTZ</sub>. When battery voltage is increased and V<sub>SHORTZ</sub> < V<sub>BAT</sub> < V<sub>BATLOW</sub>, the charge current will increase to the pre-charge current level programmed in the IPRECHG[3:0] register.

#### **Battery Over-Current Protection for System**

The BATFET will latch off, if its current limit is exceeded due to a short or large overload on the system ( $I_{BAT} > I_{BATFET_OCP}$ ). To reset this latch off and enable BATFET, the "Exit Ship Mode" procedure must be followed.

### I<sup>2</sup>C Serial Interface and Data Communication

Standard I<sup>2</sup>C interface is used to program SGM41516/ SGM41516D parameters and get status reports. I<sup>2</sup>C is well known 2-wire serial communication interface that can connect one (or more) master device(s) to some slave devices for two-way communication. The bus lines are named serial data (SDA) and serial clock (SCL). The device that initiates a data transfer is a master. A master generates the SCL signal. Slave devices have unique addresses to identify. A master is typically a micro controller or a digital signal processor.

The SGM41516/SGM41516D operate as a slave device that address is 0x6B (6BH). It has sixteen 8-bit registers, numbered from REG0x00 to REG0x0F. A register read beyond REG0x0F returns 0xFF.

**Physical Layer** The standard I<sup>2</sup>C interface of SGM41516/SGM41516D supports standard mode and fast mode communication speeds. The frequency of standard mode is up to 100kbits/s, while the fast mode is up to 400kbits/s. Bus lines are pulled high by weak current source or pull-up resistors and in logic high state with no clocking when the bus is free. The SDA and SCL pins are open-drain.

### I<sup>2</sup>C Data Communication

#### **START and STOP Conditions**

A transaction is started by taking control of the bus by master if the bus is free. The transaction is terminated by releasing the bus when the data transfer job is done as shown in Figure 13. All transactions are started by the master which applies a START condition on the bus lines to take over the bus and exchange data. At the end, the master terminates the transaction by applying one (or more) STOP condition. START condition is when SCL is high and a high to low transition on the SDA is generated by master. Similarly, a STOP is defined when SCL is high and SDA goes from low to high. START and STOP are always generated by a master. After a START and before a STOP the bus is considered busy.

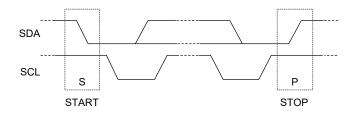


Figure 13. I<sup>2</sup>C Bus in START and STOP Conditions

#### Data Bit Transmission and Validity

The data bit (high or low) must remain stable on the SDA line during the HIGH period of the clock. The state of the SDA can only change when the clock (SCL) is LOW. For each data bit transmission, one clock pulse is generated by master. Bit transfer in  $I^2C$  is shown in Figure 14.

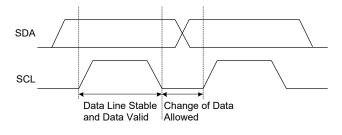


Figure 14. I<sup>2</sup>C Bus Bit Transfer

### **Byte Format**

Data is transmitted in 8-bit packets (one byte at a time). The number of bytes in one transaction is not limited. In each packet, the 8 bits are sent successively with the Most Significant Bit (MSB) first. An acknowledge (or not-acknowledge) bit must come after the 8 data bits. This bit informs the transmitter whether the receiver is ready to proceed for the next byte or not. Figure 15 shows the byte transfer process with  $I^2C$  interface.

### Acknowledge (ACK) and Not Acknowledge (NCK)

After transmission of each byte by transmitter, an acknowledge bit is replied by the receiver as ninth bit. With the acknowledge bit, the receiver informs the transmitter that the byte is received, and another byte is expected or can be sent (ACK) or it is not expected (NCK = not ACK). Clock (SCL) is always generated by the master, including the acknowledge clock pulse, no matter who is acting as transmitter or receiver. SDA line is released for receiver control during the acknowledge clock pulse. And the receiver can pull the SDA line low as ACK (reply a 0 bit) or let it be high as NCK during the SCL high pulse. After that, the master can either STOP (P) to end the transaction or send a new START (S) condition to start a new transfer (called repeated start). For example, when master wants to read a register in slave, one start is needed to send the slave address and register address, and then, without a stop condition, another start is sent by master to initiate the receiving transaction from slave. Master then sends the STOP condition and releases the bus

### **Data Direction Bit and Addressing Slaves**

The first byte sent by master after the START is always the target slave address (7 bits) and an eighth data-direction bit (R/W). R/W bit is 0 for a WRITE transaction and 1 for READ (when master is asking for data). Data direction is the same for all next bytes of the transaction. To reverse it, a new START or repeated START condition must be sent by master (STOP will end the transaction). Usually the second byte is a WRITE sending the register address that is supposed to be accesses in the next byte(s). The data transfer transaction is shown in Figure 16.

**WRITE:** If the master wants to write in the register, the third byte can be written directly as shown in Figure 17 for a single write data transfer. After receiving the ACK, master may issue a STOP condition to end the transaction or send the next register data, which will be written to the next address in a slave as multi-write. A STOP is needed after sending the last data.

**READ:** If the master wants to read a single register (Figure 18), it sends a new START condition along with device address with R/W bit = 1. After ACK is received, master reads the SDA line to receive the content of the register. Master replies with NCK to inform slave that no more data is needed (single read) or it can send an ACK to request for sending the next register content (multi-read). This can continue until an NCK is sent by master. A STOP must be sent by master in any case to end the transaction.

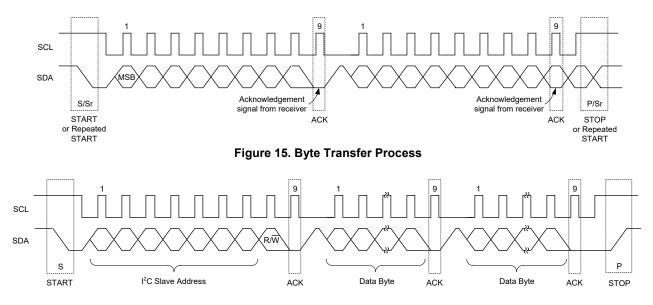
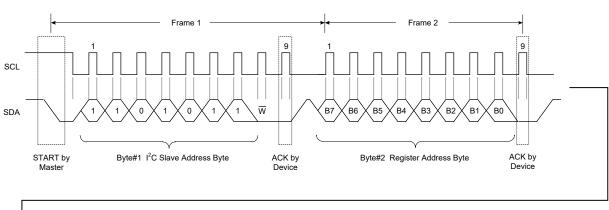


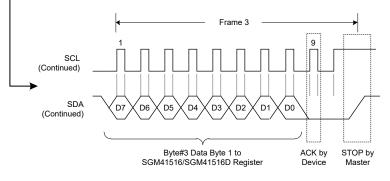
Figure 16. Data Transfer Transaction

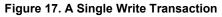


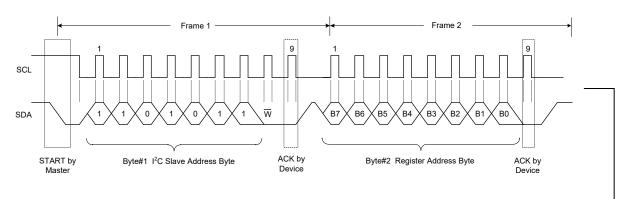
### SGM41516 SGM41516D

# **DETAILED DESCRIPTION (continued)**









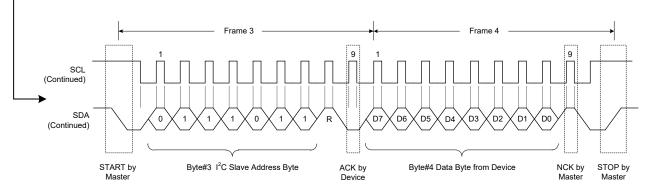


Figure 18. A Single Read Transaction



#### SGM41516 High Input Voltage, 3.78A Single-Cell Battery Charger with NVDC Power Path Management SGM41516D

### **DETAILED DESCRIPTION (continued)**

Data Transactions with Multi-Read or Multi-Write

Multi-read and multi-write are supported by SGM41516/ SGM41516D, as explained in Figure 19 and Figure 20. In the multi-write, every new data byte sent by master is written to the next register of the device. A STOP is sent whenever master is done with writing into device registers.

In a multi-read transaction, after receiving the first register data (its address is already written to the slave), the master replies with an ACK to ask the slave for sending the next register data. This can continue as much as it is needed by master. Master sends back an NCK after the last received byte and issues a STOP condition.

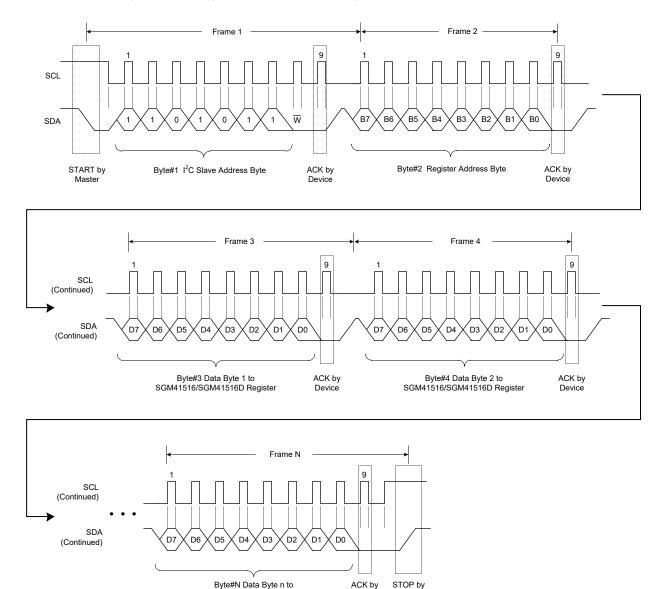


Figure 19. A Multi-Write Transaction

SGM41516/SGM41516D Register

ACK by

Device

Master





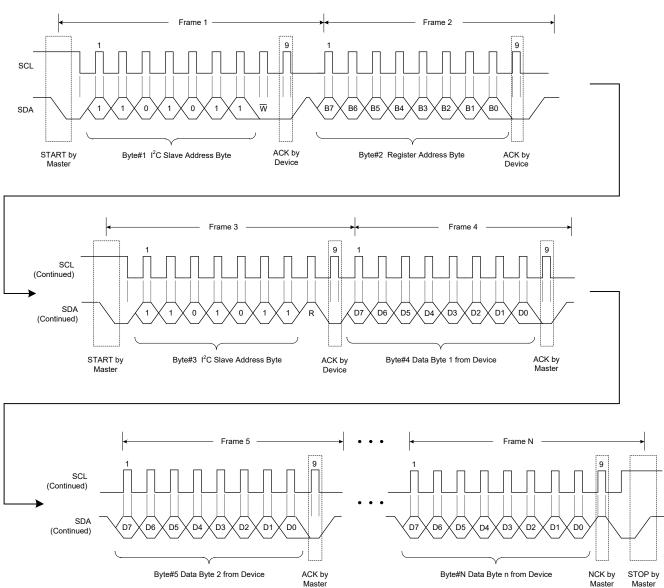


Figure 20. A Multi-Read Transaction

## **REGISTER MAPS**

All registers are 8-bit and individual bits are named from D[0] (LSB) to D[7] (MSB).

#### I<sup>2</sup>C Register Address Map

FUNCTION	STAT	FLAG	MASK	THRESHOLD SETTING	ENABLE
CHARGE	0x08[4:3] 0x09[5:4]	_	_	-	0x01[4]
VREG	0x0A[4]	_	_	0x04[7:3]	_
VREG_FT	-	_	_	0x0F[7:6]	0x0F[7:6]
ICHG	_	_	_	0x02[5:0]	_
IPRECHG	_	_	_	0x03[7:4]	_
ITERM	_	_	_	0x03[3:0]	0x05[7]
VRECHG	_	_	_	0x04[0]	_
CHG_TIMER	0x09[5:4]	_	_	0x05[2]	0x05[3]
TOPOFF_TIMER	0x0A[3]	_	_	0x04[2:1]	0x04[2:1]
 TMR2X	-	_	_	_	0x07[6]
VINDPM	0x0A[6]	_	0x0A[1]	0x06[3:0] 0x0F[1:0]	_
VDPM_BAT_TRACK	-	_	_	0x07[1:0]	0x07[1:0]
IINDPM	0x0A[5]	_	0x0A[0]	0x00[4:0]	_
Q1_FULLON	-	-	-	0x02[6]	_
 VBUS	0x08[7:5]	_	_	_	_
PG	0x0A[7]				
IINDET	0x08[2] 	-		_	-
INPUT DET DONE					0x07[7] —
	0x0E[7] (SGM41516) —		-	-	
EN_ICHG_MON	-	-	_	0.05[0.0]	0x00[6:5]
STAT_SET		-	-	0x0F[3:2]	0x00[6:5] —
SYS_MIN	0x08[0]	-		0x01[3:1]	
HIZ MODE	-	—	—	-	0x00[7]
WATCHDOG	0x09[7]	—	—	0x05[5:4] —	0x05[5:4]
WD_RST OTG	-	-	-		0x01[6]
	0x08[7:5]	—	—	0x06[5:4]	0x01[5]
MIN_BAT_SEL BOOST_LIM	-	-	-	0x01[0]	_
BATFET	_	-	_	0x02[7] 0x07[3]	0x07[5]
BATFET RST	_	_	_	-	0x07[2]
PFM	_	_			0x01[7]
DCEN		_	_	0x0F[4]	-
ARDCEN_ITS				0,01 [4]	0x05[6]
PUMPX	_	_	_	0x0D[6]	0x0D[7]
	_	_	_	0x0D[5]	
DP_VSET	—	-	—	0x0D[4:3]	-
DM_VSET	-	_	_	0x0D[2:1]	
JEITA	0x09[2:0]	-	-	-	0x0D[0]
JEITA_VT2	—	—	_	0x0C[3:2]	_
JEITA_VT3	—	—	-	0x0C[1:0]	—
JEITA_VSET_L	—	-	—	0x0C[7]	_
JEITA_VSET_H	—	-	—	0x07[4]	-
JEITA_ISET_L	—	-	_	0x05[0]	0x0C[6]
JEITA_ISET_H	-	—	-	0x0C[5:4]	—
TREG	0x08[1]	-		0x05[1]	_
TSHUT	0x09[5:4] 0x0A[2]	-		-	
BUS OVP	0x09[5:4]	-	_	0x06[7:6]	_
BAT OVP	0x09[3]	-	-	-	—
BOOST FAULT	0x09[6]	-	_	-	_
REG_RST	-	-	_	-	0x0B[7]
ITERM TIMER	-	-	_	0x05[6]	_
Part ID	-	-	-	0x0B[3:0]	-



## I<sup>2</sup>C Slave Address of SGM41516/SGM41516D: 0x6B

Bit Types:

R: Read only

SGM41516

SGM41516D

R/W: Read/Write

n: Parameter code formed by the bits as an unsigned binary number.

#### **REG0x00:** Input Current Limit Register [Reset = 0x17]

BITS	BIT NAME	DEFAULT	TYPE		DESCRIPTION	RESET BY
D[7]	EN_HIZ	0	R/W			REG_RST or Watchdog
D[6:5]	EN_ICHG_MON[1:0]	00	R/W	01 = Enable follow 10 = Reserved 11 = Disable (floa These bits turn or	ving charging state (default) ving STAT_SET[1:0] bits	REG_RST
				IINDPM[4] 1 = 1600mA	Input Current Limit Value (n: 5 bits): = 100 + 100n (mA)	
				IINDPM[3] 1 = 800mA	Offset: 100mA Range: 100mA (00000) - 3.1A (11110),	
D[4:0]	IINDPM[4:0]	10111	R/W	IINDPM[2] 1 = 400mA	3.8A (11111) Default: 2400mA (10111), not typical	REG_RST
				IINDPM[1] 1 = 200mA	IINDPM changes after an input source detection.	
				IINDPM[0] 1 = 100mA	Host can overwrite IINDPM after input source detection is completed.	



## REG0x01: Charger Control 1 Register [Reset = 0x1A]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	PFM_DIS	0	R/W	Enable PFM Mode 0 = Enable (default) 1 = Disable Enable Pulse Frequency Modulation. PFM is normally used to save power at light load by reducing converter switching frequency.	REG_RST
D[6]	WD_RST	0	R/W	I <sup>2</sup> C Watchdog Timer Reset 0 = Normal (default) 1 = Reset Watchdog timer reset control bit. Write 1 to this bit to avoid watchdog expiry. WD_RST resets to 0 after watchdog timer reset (expiry).	REG_RST or Watchdog
D[5]	OTG_CONFIG	0	R/W	Enable OTG 0 = OTG disable (default) 1 = OTG enable This bit has priority over charge enable in the CHG_CONFIG.	REG_RST or Watchdog
D[4]	CHG_CONFIG	1	R/W	Enable Battery Charging 0 = Charge disable 1 = Charge enable (default) Charge is enabled when CHG_CONFIG bit is 1 and nCE pin is pulled low.	REG_RST or Watchdog
D[3:1]	SYS_MIN[2:0]	101	R/W	Minimum System Voltage 000 = 2.6V 001 = 2.8V 010 = 3V 011 = 3.2V 100 = 3.4V 101 = 3.5V (default) 110 = 3.6V 111 = 3.7V Minimum System Voltage Value. Offset: 2.6V Range: 2.6V (000) - 3.7V (111) Default: 3.5V (101)	REG_RST
D[0]	MIN_BAT_SEL	0	R/W		REG_RST

# REG0x02: Charge Current Limit Register [Reset = 0XA2]

BITS	BIT NAME	DEFAULT	TYPE		DESCRIPTION	RESET BY
D[7]	BOOST_LIM	1	R/W	Boost Mode Curre 0 = 0.5A 1 = 1.2A (default) The current limit c value is typically h	options listed values are the minimum specs. Actual	REG_RST or Watchdog
D[6]	Q1_FULLON	0	R/W	1 = Use lower $R_{DS}$ Used to control th	SON if I <sub>INDPM</sub> < 700mA (for better accuracy) (default) SON always (fully ON for better efficiency) e on-resistance of Q1 (VBUS switch) for better surement accuracy.	REG_RST
		[5:0] 100010 R/W		ICHG[5] 1 = 1920mA		REG_RST or Watchdog
				ICHG[4] 1 = 960mA		
				ICHG[3] 1 = 480mA		
D[5:0]	ICHG[5:0]		r/vv	ICHG[2] 1 = 240mA		
				ICHG[1] 1 = 120mA		
				ICHG[0] 1 = 60mA		

#### **REG0x03:** Pre-Charge and Termination Current Limit Register [Reset = 0x22]

BITS	BIT NAME	DEFAULT	TYPE		DESCRIPTION	RESET BY
	D[7:4] IPRECHG[3:0]	0	R/W	IPRECHG[3] 1 = 480mA	Pre-Charge Current Limit (n: 4 bits): = 60 + 60n (mA) (n ≤ 12)	
D[7:4]		0	R/W	IPRECHG[2] 1 = 240mA	 Offset: 60mA Range: 60mA (0000) - 780mA (1100)	REG_RST
D[7.4]		1	R/W	IPRECHG[1] 1 = 120mA	Default: 180mA (0010) Note:	or Watchdog
		0	R/W	IPRECHG[0] 1 = 60mA	Values above 12D = 1100 (780mA) are clamped to 12D = 1100 (780mA).	
		0	R/W	ITERM[3] 1 = 480mA	Termination Current Limit (n: 4 bits):	
D[3:0]	ITERM[3:0]	0	R/W	ITERM[2] 1 = 240mA	= 60 + 60n (mA) Offset: 60mA Range: 60mA (0000) - 960mA (1111)	REG_RST or Watchdog
D[3.0]		1	R/W	ITERM[1] 1 = 120mA		
		0 R/W ITERM[0] 1 = 60mA				



## REG0x04: Battery Voltage Limit Register [Reset = 0x58]

BITS	BIT NAME	DEFAULT	TYPE		DESCRIPTION	RESET BY
		0	R/W	VREG[4] 1 = 512mV	Charge Voltage Limit (n: 5 bits): = 3856 + 32n (mV) if n ≤ 24, n≠15;	
		1	R/W	VREG[3] 1 = 256mV	= 4.352V if n = 15 Offset: 3.856V	
D[7:3]	VREG[4:0]	0	R/W	VREG[2] 1 = 128mV	Range: 3.856V (00000) - 4.624V (11000) Default: 4.208V (01011) Special Value: 4.352V (01111)	REG_RST or Watchdog
		1	R/W	VREG[1] 1 = 64mV	Note:	
		1	R/W	VREG[0] 1 = 32mV	Values above 24D = 11000 (4.624V) are clamped to 24D = 11000 (4.624V).	
D[2:1]	TOPOFF_TIMER[1:0]	00	R/W	detected.	fault) ision time added after the termination condition is ng terminates as soon as termination conditions	REG_RST or Watchdog
D[0]	VRECHG	0	R/W	1 = 200mV below	VREG[4:0] (default) VREG[4:0] <i>i</i> ill start if a fully charged battery voltage drops below	REG_RST or Watchdog



## REG0x05: Charger Control 2 Register [Reset = 0x9F]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	EN_TERM	1	R/W	Charging Termination Enable 0 = Disable 1 = Enable (default)	REG_RST or Watchdog
D[6]	ARDCEN_ITS	0	R/W	DCEN Reset Enable or ITERM Timer Setting 0 = Allow resetting DCEN or set 200ms (default) 1 = Don't allow resetting DCEN or set 16ms When DCEN = 1 and IBUS over-current occurs, set this bit 0 or 1 to allow resetting DCEN or not. When DCEN = 0, set this bit 0 or 1 to set ITERM detection timer to 200ms or 16ms.	REG_RST or Watchdog
D[5:4]	WATCHDOG[1:0]	01	R/W	Watchdog Timer Setting 00 = Disable watchdog timer 01 = 40s (default) 10 = 80s 11 = 160s Expiry time of the watchdog timer if it is not reset.	REG_RST or Watchdog
D[3]	EN_TIMER	1	R/W	Charge Safety Timer Enable 0 = Disable 1 = Enable (default) When enabled the pre-charge and fast charge periods are included in the timing.	REG_RST or Watchdog
D[2]	CHG_TIMER	1	R/W	Charge Safety Timer Setting 0 = 7h 1 = 16h (default)	REG_RST or Watchdog
D[1]	TREG	1	R/W	Thermal Regulation Threshold 0 = 80°C 1 = 120°C (default) For Buck mode.	REG_RST or Watchdog
D[0]	JEITA_ISET_L (0°C - 10°C)	1	R/W	JEITA Charging Current $0 = 50\%$ of $I_{CHG}$ $1 = 20\%$ of $I_{CHG}$ (default) When JEITA_ISET_L_EN = 1.	REG_RST or Watchdog



# REG0x06: Charger Control 3 Register [Reset = 0xE6]

BITS	BIT NAME	DEFAULT	TYPE		DESCRIPTION	RESET BY
D[7:6]	OVP[1:0]	11	R/W	VAC Pin OVP T 00 = 5.5V 01 = 6.5V (5V ir 10 = 10.5V (9V 11 = 14V (12V i OVP threshold t	nput) input) input) (default)	REG_RST
D[5:4]	BOOSTV[1:0]	10	R/W	Boost Mode Vo 00 = 4.85V 01 = 5.00V 10 = 5.15V (def 11 = 5.30V	Itage Regulation	REG_RST
		VINDPM[3] 1 = 800mV = Offset + 0.1n	VINDPM Threshold (n: 4 bits): = Offset + 0.1n (V) — Offset: 3.9V (VINDPM OS = 00, default)			
				VINDPM[2] 1 = 400mV	Range: 3.9V (0000) - 5.4V (1111) Default: 4.5V (0110)	
D[3:0]	VINDPM[3:0]	0110	R/W	VINDPM[1] 1 =200mV	<ul> <li>Offset: 5.9V (VINDPM_OS = 01)</li> <li>Range: 5.9V (0000) - 7.4V (1111)</li> <li>Offset: 7.5V (VINDPM_OS = 10)</li> <li>Decemp 7.5V (2000) - 00 ((1111))</li> </ul>	REG_RST
				VINDPM[0] 1 =100mV	Range: 7.5V (0000) - 9V (1111) Offset: 10.5V (VINDPM_OS = 11) Range: 10.5V (0000) - 12V (1111)	

#### REG0x07: Charger Control 4 Register [Reset = 0x4C]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	IINDET_EN	0	R/W	Input Current Limit Detection 0 = Not in input current limit detection (default) 1 = Force input current limit detection when VBUS is present Reloads with 0 when input detection is completed.	REG_RST or Watchdog
D[6]	TMR2X_EN	1	R/W	Enable Half Clock Rate Safety Timer 0 = Disable 1 = Safety timer slows down during DPM, JEITA cool, or thermal regulation (default) Slow down by a factor of 2.	REG_RST or Watchdog
D[5]	BATFET_DIS	0	R/W	Disable BATFET 0 = Allow BATFET (Q4) to turn on (default) 1 = Turn off BATFET (Q4) after a $t_{SM_DLY}$ delay time (REG0x07 D[3]) $t_{SM_DLY}$ is typically 12.3 seconds.	REG_RST
D[4]	JEITA_VSET_H (45℃ - 60℃)	0	R/W	JEITA Charging Voltage 0 = Set charge voltage to the lower of 4.1V and $V_{REG}$ (default) 1 = Set charge voltage to $V_{REG}$	REG_RST or Watchdog
D[3]	BATFET_DLY	1	R/W	BATFET Turn Off Delay Control 0 = Turn off BATFET immediately 1 = Turn off BATFET after t <sub>SM_DLY</sub> (default) BATFET_DIS bit is set.	REG_RST
D[2]	BATFET_RST_EN	1	R/W	Enable BATFET Reset 0 = Disable BATFET reset 1 = Enable BATFET reset (default)	REG_RST or Watchdog
D[1:0]	VDPM_BAT_ TRACK[1:0]	00	R/W	Dynamic VINDPM Tracking $00 = Disable (V_{INDPM} set by register)$ $01 = V_{BAT} + 200mV$ $10 = V_{BAT} + 250mV$ $11 = V_{BAT} + 300mV$ Set V <sub>INDPM</sub> to track V <sub>BAT</sub> voltage. Actual V <sub>INDPM</sub> is the larger of VINDPM[3:0] and this register value.	REG_RST



## REG0x08: Charger Status 1 Register [Reset = 0xXX]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7:5]	VBUS_STAT[2:0]	XXX	R	VBUS Status Register (SGM41516D) 000 = No input 001 = USB host SDP 010 = USB CDP (1.5A) 011 = USB DCP (2.4A) 101 = Unknown adaptor (500mA) 110 = Non-standard adaptor (1A/2A/2.1A/2.4A) 111 = OTG VBUS Status Register (SGM41516) 000 = No input 001 = USB host SDP (500mA) $\rightarrow$ PSEL HIGH 010 = Adaptor 2.4A $\rightarrow$ PSEL LOW 111 = OTG Other values are reserved. Current limit value is reported in IINDPM[4:0] register.	N/A
D[4:3]	CHRG_STAT[1:0]	xx	R	Charging Status 00 = Charge disable 01 = Pre-charge (V <sub>BAT</sub> < V <sub>BATLOW</sub> ) 10 = Fast charging (constant current or voltage) 11 = Charging terminated	N/A
D[2]	PG_STAT	x	R	Input Power Status (VBUS in good voltage range and not poor) 0 = Input power source is not good 1 = Input power source is good	N/A
D[1]	THERM_STAT	x	R	Thermal Regulation Status 0 = Not in thermal regulation 1 = In thermal regulation	N/A
D[0]	VSYS_STAT	x	R	System Voltage Regulation Status 0 = Not in VSYSMIN regulation (V <sub>BAT</sub> > V <sub>SYS_MIN</sub> ) 1 = In VSYSMIN regulation (V <sub>BAT</sub> < V <sub>SYS_MIN</sub> )	N/A

## REG0x09: Fault Status Register [Reset = 0xXX]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	WATCHDOG_FAULT	x	R	Watchdog Fault Status 0 = Normal (no fault) 1 = Watchdog timer expired	N/A
D[6]	BOOST_FAULT	x	R	Boost Mode Fault Status 0 = Normal 1 = VBUS is overloaded in OTG, or VBUS OVP, or battery voltage too low (any condition that prevents Boost starting)	N/A
D[5:4]	CHRG_FAULT[1:0]	хх	R	Charging Fault Status 00 = Normal 01 = Input fault (VAC OVP or V <sub>BAT</sub> < V <sub>VBUS</sub> < 3.8V) 10 = Thermal shutdown 11 = Charge safety timer expired	N/A
D[3]	BAT_FAULT	х	R	Battery Fault Status 0 = Normal 1 = Battery over-voltage (BATOVP)	N/A
D[2:0]	NTC_FAULT[2:0]	xxx	R	JEITA Condition Based on Battery NTC Temperature Measurement 000 = Normal 010 = Warm 011 = Cool (Buck mode only) 101 = Cold 110 = Hot NTC fault bits are updated in real time and does not need a read to reset.	N/A



## REG0x0A: Charger Status 2 Register [Reset = 0xXX]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	VBUS_GD	x	R	Good Input Source Detected 0 = A good VBUS is not attached 1 = A good VBUS attached	N/A
D[6]	VINDPM_STAT	x	R	Input Voltage Regulation (Dynamic Power Management) 0 = Not in VINDPM 1 = In VINDPM	N/A
D[5]	IINDPM_STAT	x	R	Input Current Regulation (Dynamic Power Management) 0 = Not in IINDPM 1 = In IINDPM	N/A
D[4]	CV_STAT	x	R	CV Mode Status Indicator when DCEN = 1 0 = VBAT is lower than VREG 1 = VBAT approaches to VREG	N/A
D[3]	TOPOFF_ACTIVE	x	R	Active Top-Off Timer Counting Status 0 = Top-off timer not counting 1 = Top-off timer counting	N/A
D[2]	ACOV_STAT	x	R	Input Over-Voltage Status (AC adaptor is the input source) 0 = No over-voltage (no ACOV) 1 = Over-voltage detected (ACOV)	N/A
D[1]	VINDPM_INT_MASK	0	R/W	VINDPM Event Detection Interrupt Mask 0 = Allow VINDPM INT pulse (default) 1 = Mask VINDPM INT pulse	REG_RST
D[0]	IINDPM_INT_MASK	0	R/W	IINDPM Event Detection Mask 0 = Allow IINDPM to send INT pulse (default) 1 = Mask IINDPM INT pulse	REG_RST

# REG0x0B: Part Information Register [Reset = 0x6X]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY	
D[7]	REG_RST	0	R/W	Register Reset 0 = No effect (keep current register settings) (default) 1 = Reset R/W bits of all registers to the default and reset safety timer (It also resets itself to 0 after register reset is completed.)	REG_RST	
			1			
D[6:3] PN[3:0]	DNI2-01	1	R	Part ID 1100 - SCM41516	N/A	
	0	ĸ	1100 = SGM41516 1101 = SGM41516D	N/A		
		х				
D[2]	SGMPART	1	R		N/A	
D[1:0]	DEV_REV[1:0]	хх	R	Revision	N/A	



## **REG0x0C:** Charger Control 5 Register [Reset = 0x75]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	JEITA_VSET_L (0°C - 10°C)	0	R/W	JEITA Charging Voltage 0 = Set charge voltage to $V_{REG}$ (default) 1 = Set charge voltage to the lower of 4.1V and $V_{REG}$	REG_RST or Watchdog
D[6]	JEITA_ISET_L_EN (0°C - 10°C)	1	R/W	Charge Enable during Cool Temperature 0 = Disable 1 = Enable (default)	REG_RST or Watchdog
D[5:4]	JEITA_ISET_H[1:0] (45°C - 60°C)	11	R/W	Charge Current Setting during Warm Temperature $00 = 0\%$ of $I_{CHG}$ $01 = 20\%$ of $I_{CHG}$ $10 = 50\%$ of $I_{CHG}$ $11 = 100\%$ of $I_{CHG}$ (default) In warm condition, the safety timer does not become 2X.	REG_RST or Watchdog
D[3:2]	JEITA_VT2[1:0]	01	R/W	$ \begin{array}{l} \mbox{JEITA Cool Threshold Setting} \\ 00 = V_{T2} = 70.75\% \ (5.5\ ^{\circ}C) \\ 01 = V_{T2} = 68.25\% \ (10\ ^{\circ}C) \ (default) \\ 10 = V_{T2} = 65.25\% \ (15\ ^{\circ}C) \\ 11 = V_{T2} = 62.25\% \ (20\ ^{\circ}C) \\ \end{array} $	REG_RST or Watchdog
D[1:0]	JEITA_VT3[1:0]	01	R/W	JEITA Warm Threshold Setting $00 = V_{T3} = 48.25\% (40^{\circ}C)$ $01 = V_{T3} = 44.75\% (45^{\circ}C) (default)$ $10 = V_{T3} = 40.75\% (50.5^{\circ}C)$ $11 = V_{T3} = 37.75\% (54.5^{\circ}C)$	REG_RST or Watchdog

#### **REG0x0D:** Charger Control 6 Register [Reset = 0x01]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	EN_PUMPX	0	R/W	Current Pulse Control Enable 0 = Disable (default) 1 = Enable (PUMPX_UP and PUMPX_DN)	REG_RST or Watchdog
D[6]	PUMPX_UP	0	R/W	Current Pulse Control Voltage up Enable 0 = Disable (default) 1 = Enable This bit is can only be set when EN_PUMPX bit is set and returns to 0 after current pulse control sequence is completed.	REG_RST or Watchdog
D[5]	PUMPX_DN	0	R/W	Current Pulse Control Voltage down Enable 0 = Disable (default) 1 = Enable This bit is can only be set when EN_PUMPX bit is set and returns to 0 after current pulse control sequence is completed.	REG_RST or Watchdog
D[4:3]	DP_VSET[1:0]	00	R/W	D+ Output Voltage Setting 00 = HIZ (default) 01 = 0V 10 = 0.6V 11 = 3.3V Register bits are reset to default value when input source is plugged-in and can be changed after D+/D- detection is completed.	REG_RST or Watchdog
D[2:1]	DM_VSET[1:0]	00	R/W	D- Output Voltage Setting 00 = HIZ (default) 01 = 0V 10 = 0.6V 11 = 3.3V Register bits are reset to default value when input source is plugged-in and can be changed after D+/D- detection is completed.	REG_RST or Watchdog
D[0]	JEITA_EN	1	R/W	JEITA Enable 0 = Disable 1 = Enable (default)	REG_RST or Watchdog



## REG0x0E: Charger Flag Register [Reset = 0xXX]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7]	INPUT_DET_DONE	x	R	VBUS Input Detection Done Flag 0 = Normal 1 = Detection done PSEL or DPDM detection done flag after VBUS plug in or set FORCE_DPDM = 1.	NA
D[6:0]	Reserved	XXXXXXX	R	Reserved	NA

#### **REG0x0F:** Charger Control 7 Register [Reset = 0x00]

BITS	BIT NAME	DEFAULT	TYPE	DESCRIPTION	RESET BY
D[7:6]	VREG_FT	00	R/W	$ \begin{array}{l} VREG Fine Tuning \\ 00 = Disable (default) \\ 01 = V_{REG} + 8mV \\ 10 = V_{REG} - 8mV \\ 11 = V_{REG} - 16mV \end{array} $	REG_RST or Watchdog
D[5]	Reserved	0	R/W	Reserved	REG_RST or Watchdog
D[4]	DCEN	0	R/W	DCEN Pin Output Control 0 = Low (default) 1 = High When BATOVP time reaches $t_{BATOVP_DCEN}$ , the bit resets to default.	REG_RST or Watchdog
D[3:2]	STAT_SET[1:0]	00	R/W	STAT Pin Output Setting 00 = LED off (HIZ) (default) 01 = LED on (low) 10 = LED blinking 1s on 1s off 11 = LED blinking 1s on 3s off This bits only takes effect when EN_ICHG_MON[1:0] = 01.	REG_RST or Watchdog
D[1:0]	VINDPM_OS[1:0]	00	R/W	VINDPM Offset 00 = 3.9V (default) 01 = 5.9V 10 = 7.5V 11 = 10.5V	REG_RST



#### APPLICATION INFORMATION

The SGM41516/SGM41516D are typically used as a charger with power path management in smart phones, tablets and other portable devices. In the design, it comes along with a host controller (a processor with  $I^2C$  interface) and a single-cell Li-lon or Li-polymer battery.

#### **Detailed Design Procedure**

#### **Inductor Design**

Small energy storage elements (inductor and capacitor) can be used due to the high frequency (1.5MHz) switching converter used in the SGM41516/SGM41516D. Inductor should tolerate currents higher than the maximum charge current ( $I_{CHG}$ ) plus half the inductor peak to peak ripple current ( $\Delta I$ ) without saturation:

$$I_{SAT} > I_{CHG} + \frac{\Delta I}{2}$$
 (3)

The inductor ripple current is determined by the input voltage ( $V_{VBUS}$ ), duty cycle (D =  $V_{BAT}/V_{VBUS}$ ), switching frequency (f<sub>S</sub> = 1.5MHz) and the inductance (L). In CCM:

$$\Delta I = \frac{V_{VBUS} \times D \times (1 - D)}{f_{s} \times L}$$
(4)

Inductor ripple current is maximum when D  $\approx$  0.5. If the input voltage range (V\_{VBUS}) is limited higher, D values can be considered.

In the practical designs, inductor peak to peak current ripple is selected in a range from 20% to 40% of the maximum DC current  $\Delta I = (0.2 \sim 0.4) \times I_{CHG}$  for a good trade-off between inductor size and efficiency. Selecting higher ripple allows choosing of smaller inductance.

For each application,  $V_{VBUS}$  and  $I_{CHG}$  are known, so L can be calculated from (4) and current rating of the inductor can be selected from (3). Choose an inductor that has small DCR and core losses at 1.5MHz to have high efficiency and cool operation at full load.

#### Input Capacitor Design

Select low ESR ceramic input capacitor (X7R or X5R) with sufficient voltage and RMS ripple current rating for decoupling of the input switching ripple current ( $I_{CIN}$ ). The RMS ripple current in the worst case is around the  $I_{CHG}/2$  when D  $\approx$  0.5. If

the converter does not operate at D  $\approx$  50%, the worst case capacitor RMS current can be estimated from (5) in which D is the closest operating duty cycle to 0.5.

$$I_{CIN} = I_{CHG} \times \sqrt{D \times (1 - D)}$$
(5)

For SGM41516/SGM41516D, place  $C_{IN}$  across PMID and GND pins close to the chip. Voltage rating of the capacitor must be at least 25% higher than the normal input voltage to minimize voltage derating. A rating of 25V or higher is preferred for a 15V input voltage. For a 13.5V input voltage, the preferred rating is 25V or higher.

A  $C_{IN}$  = 22µF is suggested.

#### **Output Capacitor Design**

The output capacitance (on the system) must have enough RMS (ripple) current rating to carry the inductor switching ripple and provide enough energy for system transient current demands.  $I_{COUT}$  ( $C_{OUT}$  RMS current) can be calculated by:

$$I_{COUT} = \frac{I_{RIPPLE}}{2 \times \sqrt{3}} \approx 0.29 \times I_{RIPPLE}$$
(6)

And the output voltage ripple can be calculated by:

$$\Delta V_{o} = \frac{V_{out}}{8LC_{out}f_{s}^{2}} \left(1 - \frac{V_{out}}{V_{VBUS}}\right)$$
(7)

Increasing L or  $C_{\text{OUT}}$  (the LC filter) can reduce the ripple.

The internal loop compensation of the device is optimized for >  $22\mu$ F ceramic output capacitor. 10V, X7R (or X5R) ceramic capacitors are recommended for the output.

#### **Input Power Supply Considerations**

To power the system from the SGM41516/SGM41516D, either an input power source with a voltage range from 3.9V to 13.5V and at least 100mA current rating should power VBUS, or a single-cell Li-lon battery with voltage higher than  $V_{BAT_UVLOZ}$  should be connected to BAT pin of the device. The input source must have enough current rating to allow maximum power delivery through charger (Buck converter) to the system.



# **APPLICATION INFORMATION (continued)**

#### **Layout Guidelines**

The switching node (SW) creates very high frequency noises, which are several times higher than  $f_{SW}$  (1.5MHz) due to sharp rise and fall of the voltage and current in the switches. To reduce the ringing issues and noise generation, it is important to design a proper layout for minimizing the current path impedance and loop area. A graphical guideline for the current loops and their frequency content is provided in Figure 21. The following considerations can help to make a better layout.

1. Place the input capacitor between PMID and GND pins as close as possible to the chip with the shortest copper connections (avoid vias). Choose the smallest capacitor size.

2. Connect one pin of the inductor as close as possible to the SW pin of the device and minimize the copper area connected to the SW node to reduce capacitive coupling from SW area to nearby signal traces. This decreases the noise induced through parasitic stray capacitances and displacement currents to other conductors. SW connection should be wide enough to carry the charging current. Keep other signals and traces away from SW if possible.

3. Place output capacitor GND pin as close as possible to the GND pin of the device and the GND pin of input capacitor  $C_{IN}$ .

It is better to avoid using vias for these connections and keep the high frequency current paths short enough and on the same layer. A GND copper layer under the component layer helps to reduce noise emissions. Pay attention to the DC current and AC current paths in the layout and keep them short and decoupled as much as possible.

4. For analog signals, it is better to use a separate analog ground (AGND) branched only at one point from GND pin. To avoid high current flow through the AGND path, it should be connected to GND only at one point (preferably the GND pin).

5. Place decoupling capacitors close to the IC pins with the shortest copper connections.

6. Solder the exposed thermal pad of the package to the PCB ground planes. Ensure that there are enough thermal vias directly under the IC, connecting to the ground plane on the other layers for better heat dissipation and cooling of the device.

7. Select proper sizes for the vias and ensure enough copper is available to carry the current for the given current path. Vias usually have some considerable parasitic inductance and resistance.

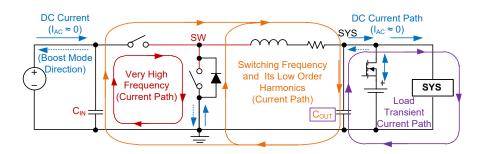


Figure 21. The Paths and Loops Carrying High Frequency, DC Currents and Very High Frequency (for Layout Design Consideration)

# **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

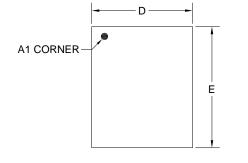
Changes from Original (DECEMBER 2022) to REV.A	Page
Changed from product preview to production data	All

-30 **х** Фd

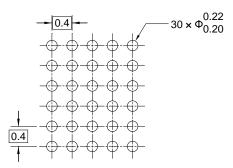
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# PACKAGE OUTLINE DIMENSIONS

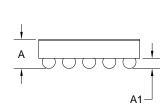
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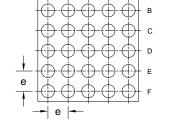


TOP VIEW



RECOMMENDED LAND PATTERN (Unit: mm)





SIDE VIEW

**BOTTOM VIEW** 

Symbol	Dimensions In Millimeters							
Symbol	MIN	MOD	MAX					
A	0.525	0.575	0.625					
A1	0.180	0.200	0.220					
D	1.970	2.000	2.030					
E	2.370	2.400	2.430					
d	0.230	0.260	0.290					
е	0.400 BSC							

NOTE: This drawing is subject to change without notice.



# TAPE AND REEL INFORMATION

#### **REEL DIMENSIONS**



NOTE: The picture is only for reference. Please make the object as the standard.

#### KEY PARAMETER LIST OF TAPE AND REEL

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
WLCSP-2.0×2.4-30B	7"	9.0	2.15	2.55	0.75	4.0	4.0	2.0	8.0	Q1

#### **CARTON BOX DIMENSIONS**



NOTE: The picture is only for reference. Please make the object as the standard.

#### **KEY PARAMETER LIST OF CARTON BOX**

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton	
7" (Option)	368	227	224	8	
7"	442	410	224	18	00002

